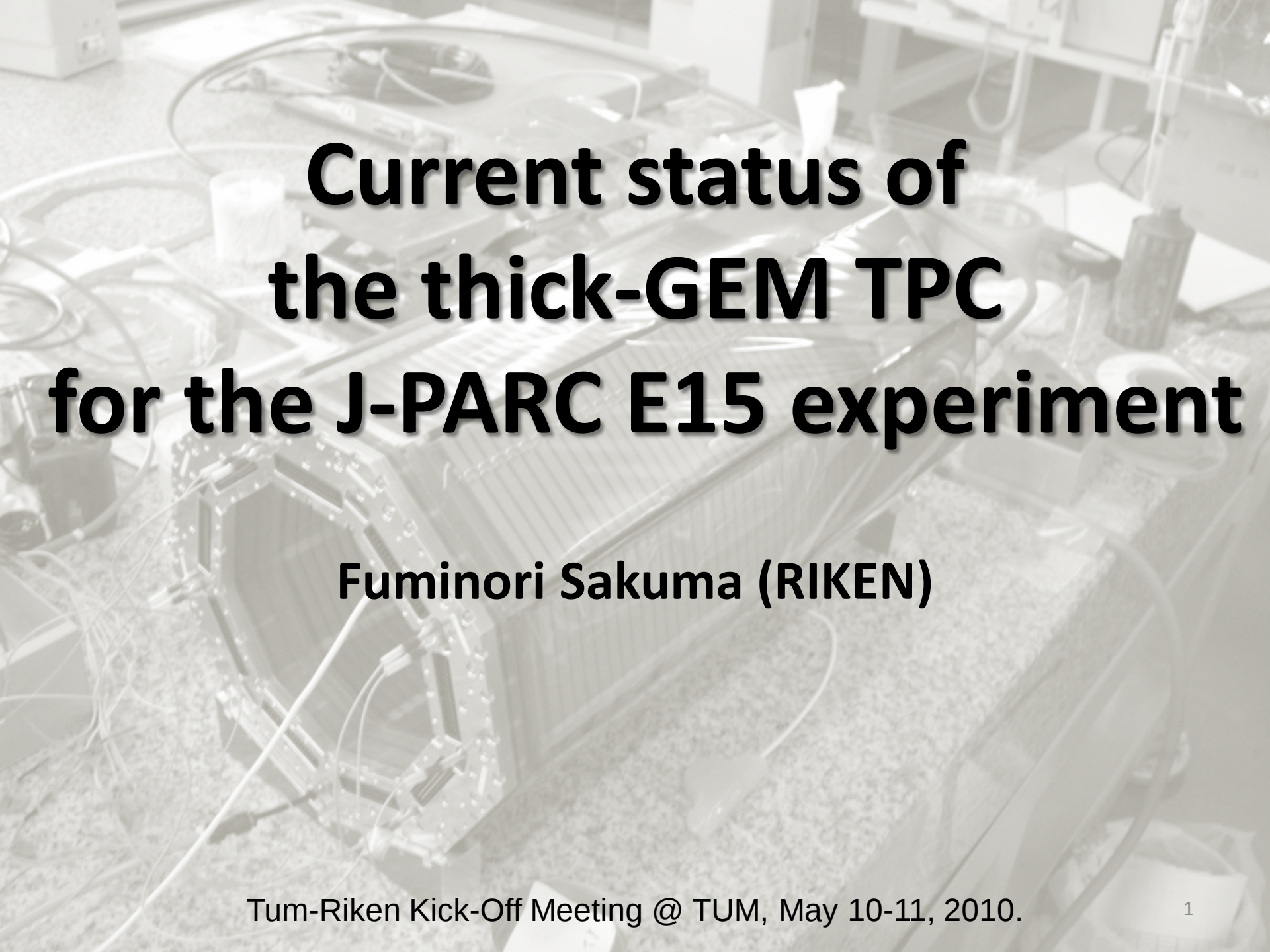




Current status of the thick-GEM TPC for the J-PARC E15 experiment

Fuminori Sakuma (RIKEN)

Contents

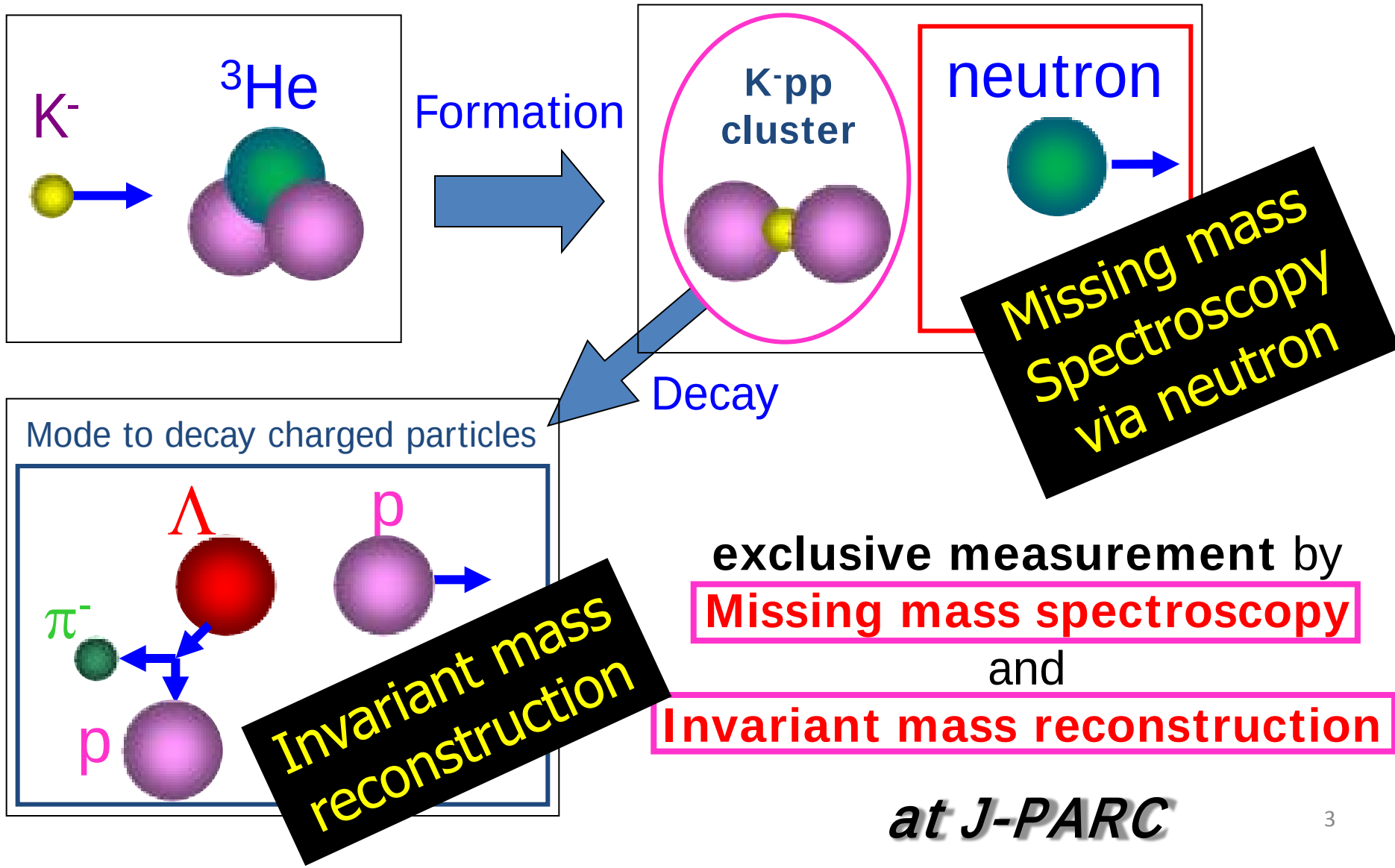
- Introduction
- TGEM-TPC for the J-PARC E15 exp.
- Thick GEM (TGEM)

goal: gain $\sim 10^4$ with stable operation in P10 @ NTP

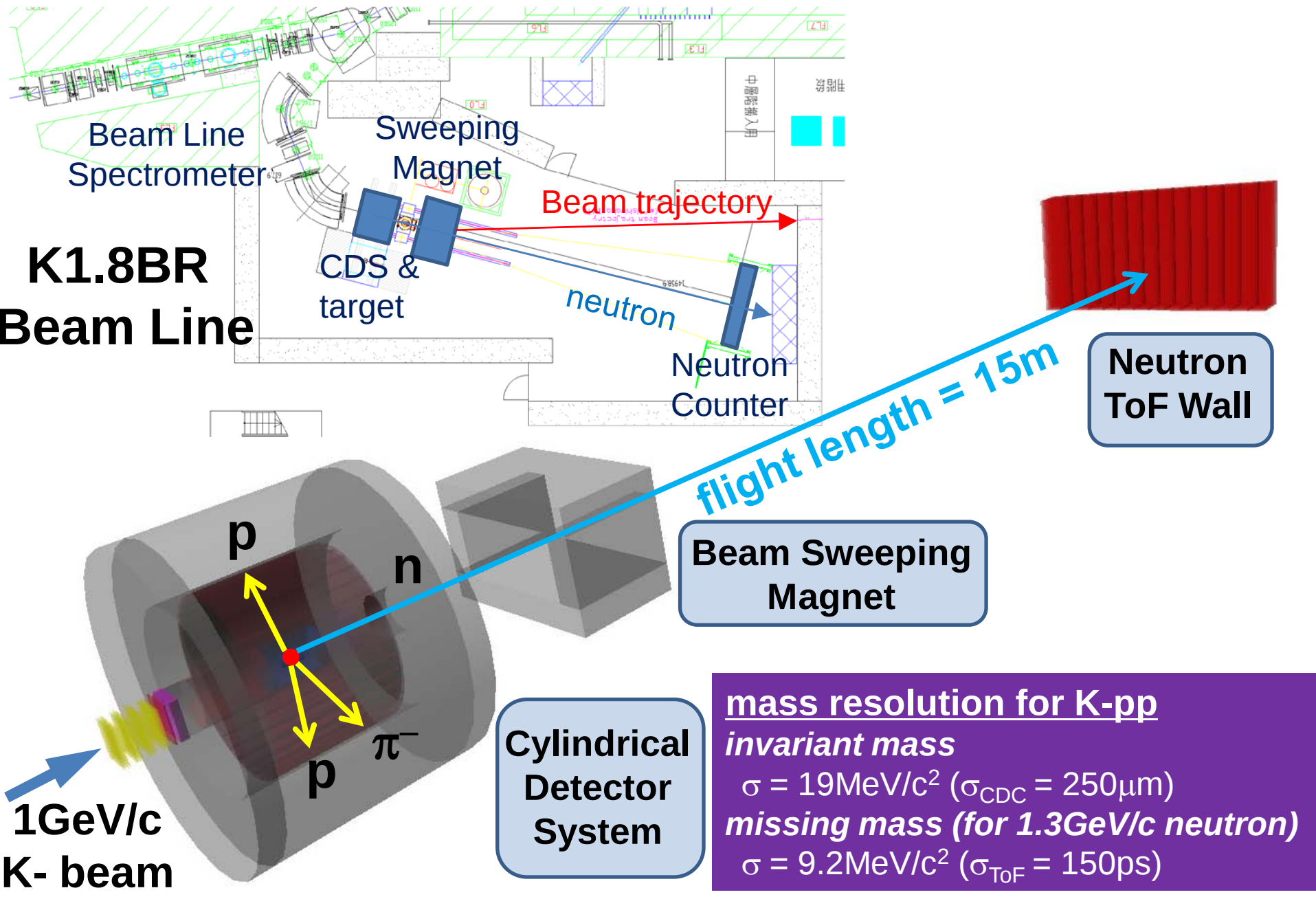
- Results of TGEMs in P10 @ NTP
 - Cu-electrode TGEMs
 - C-electrode TGEMs
 - C/Cu-electrode Hybrid TGEMs
- Summary

J-PARC E15 Experiment

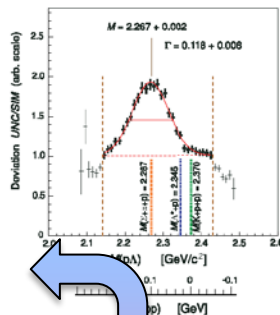
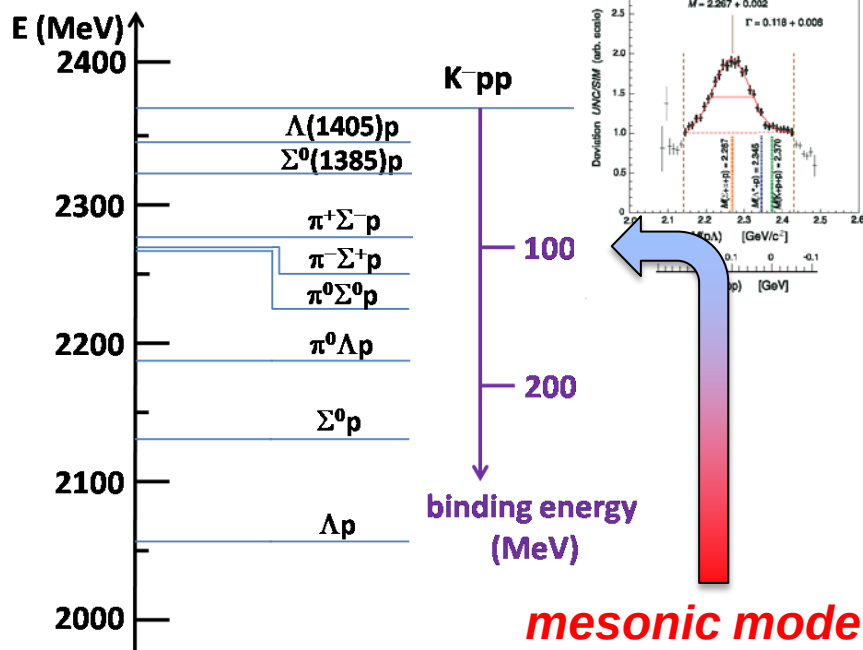
search for K-pp bound state using ${}^3\text{He}(\text{K}^-, \text{n})$ reaction



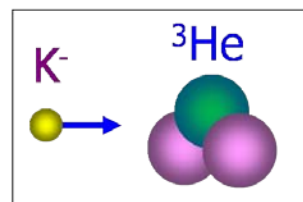
J-PARC E15 Setup



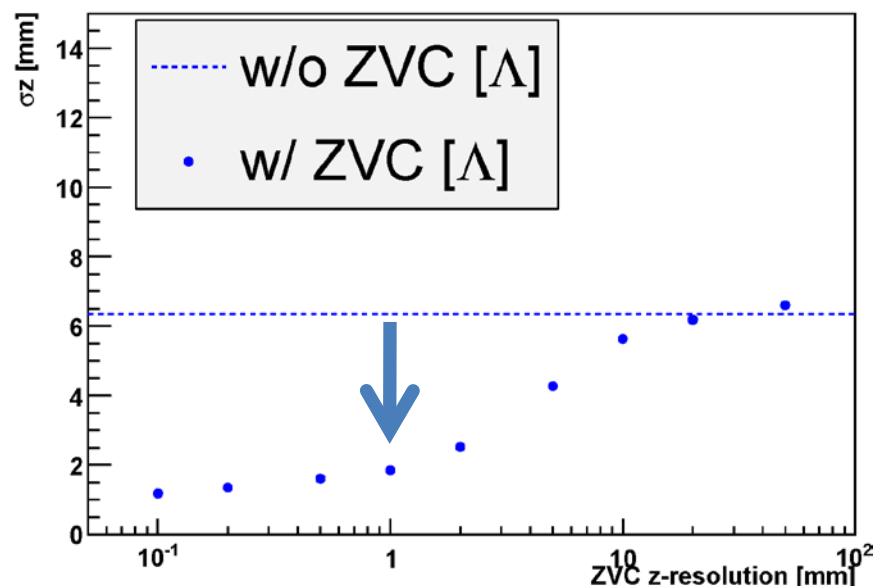
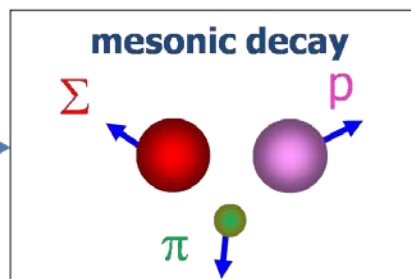
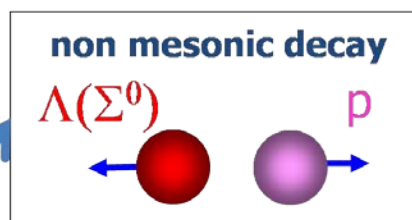
measurement of mesonic decay-mode of K^-pp



important to measure not only non-mesonic decay mode but also mesonic decay mode



Reaction



Thick-GEM TPC
improves z-resolution

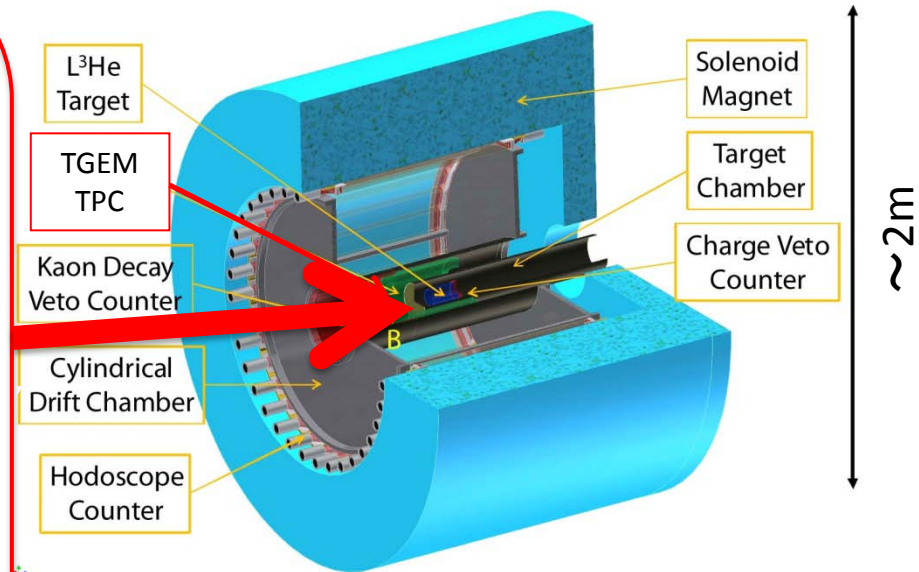
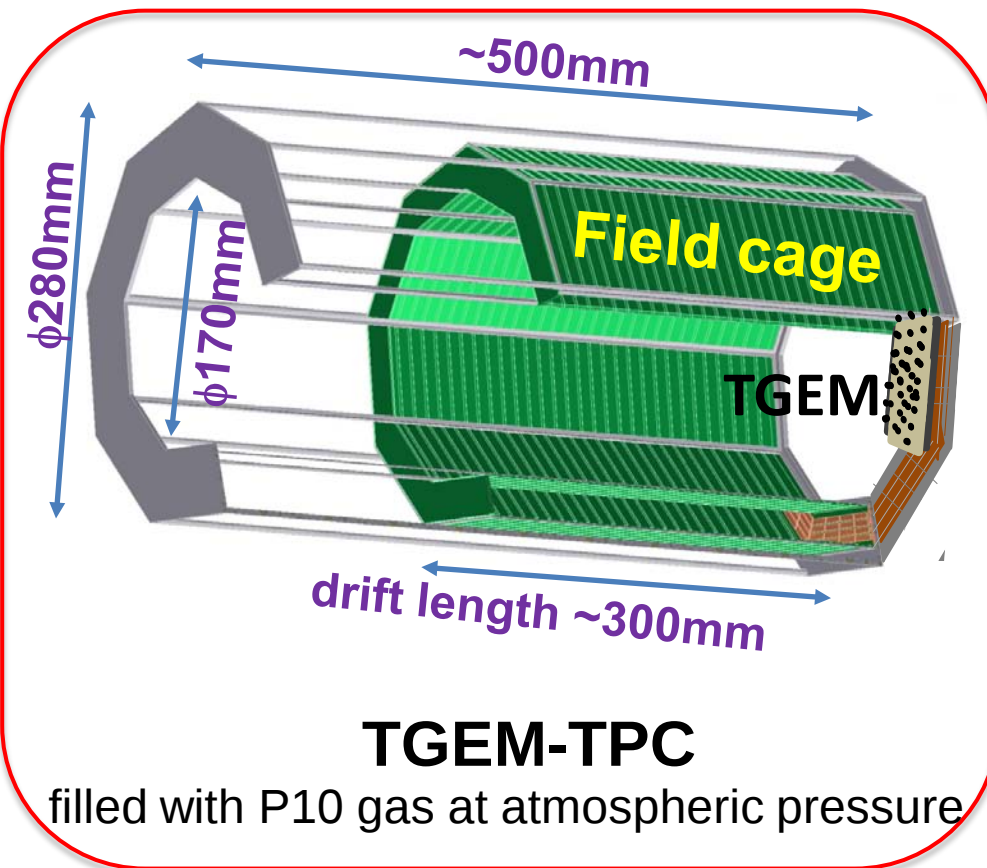
TGEM-TPC

for the J-PARC E15 exp.

TGEM-TPC for the J-PARC E15 exp.

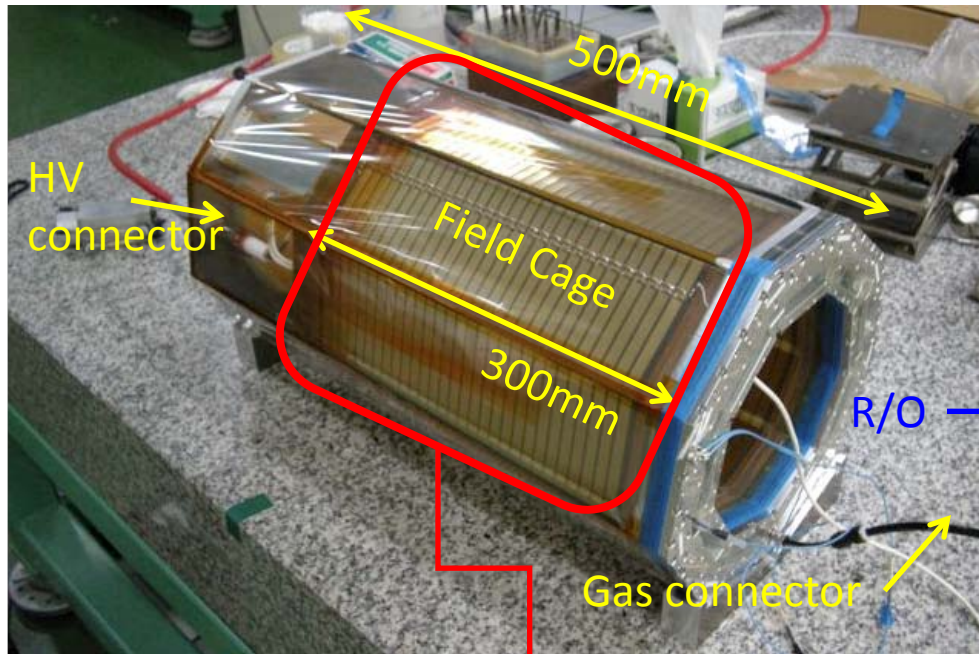
●TGEM-TPC is located at the center of Cylindrical Detector System

- located between CDC and target-chamber
- cover the CDC acceptance of AUVA
- minimum materials in the acceptance
- 1mm spatial resolution in the z-direction



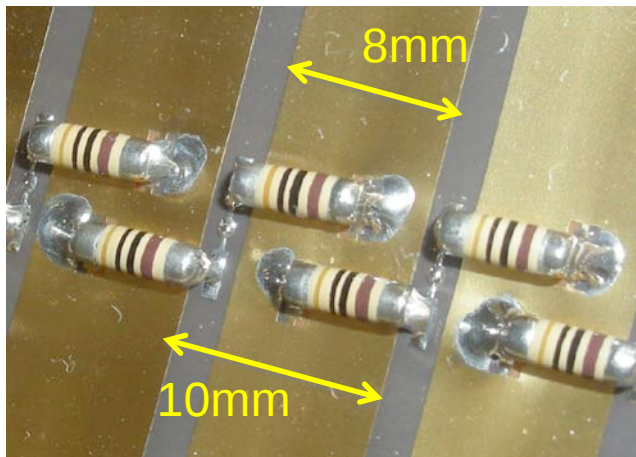
Cylindrical Detector System

completed TGEM-TPC

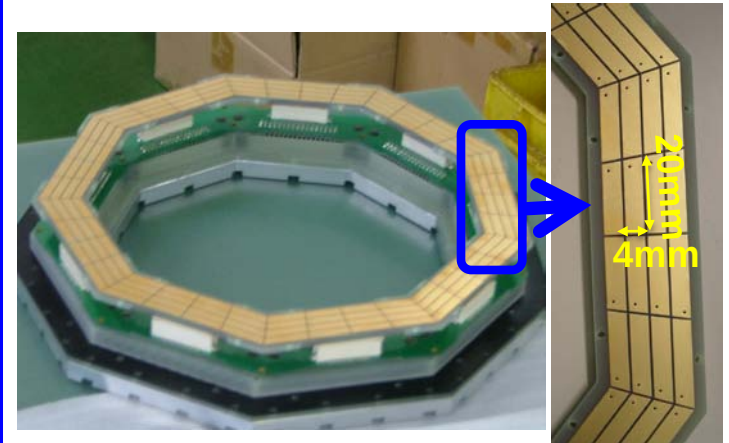


field strip

- double sided
- FPC
- 8mm strip
- 10mm pitch

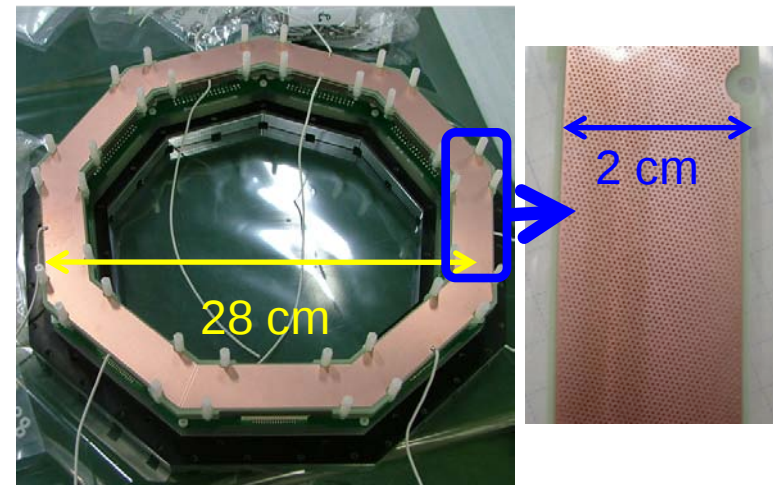


R/O pad size $4\text{mm} \times 20\text{mm}$



of pad = $4 \times 4 \times 9 = 144$

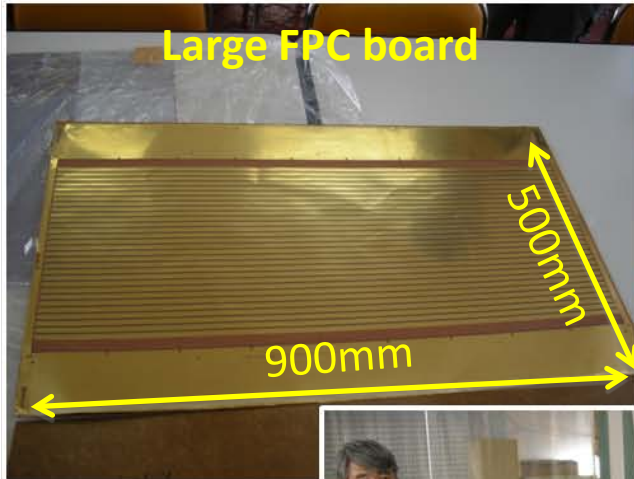
TGEM



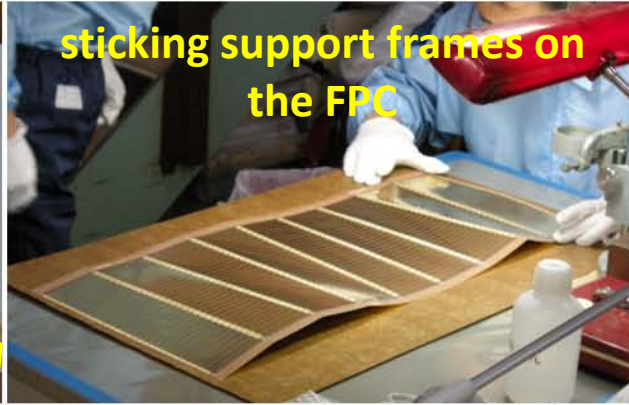
non-necessity of support-structure!

making of Field Cages

Large FPC board



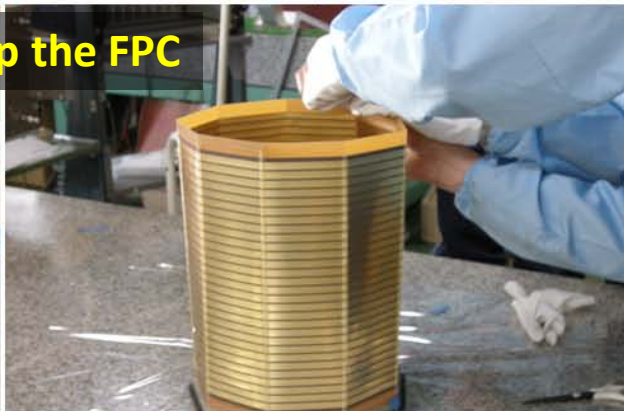
sticking support frames on the FPC



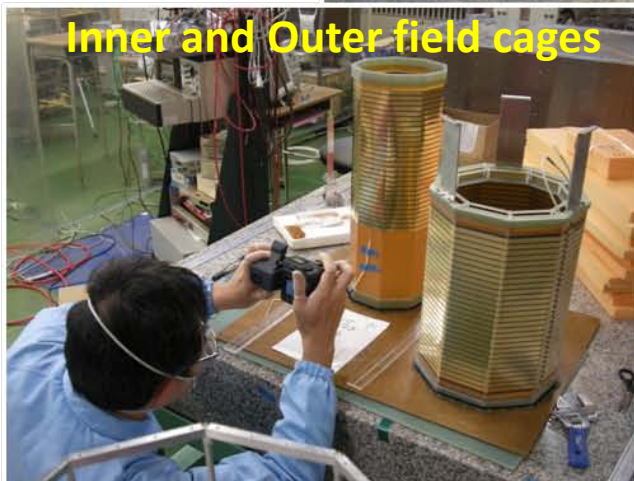
soldering resisters(1MΩ)



rolling up the FPC



Inner and Outer field cages



uniting the two cages



completed



HV & Readout

HV connector
(LEMO, max. 15kV)

150mm

preamp attachment (test)

readout pad

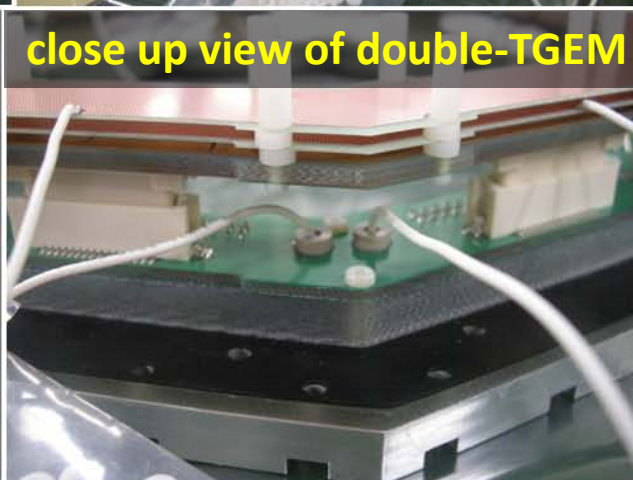
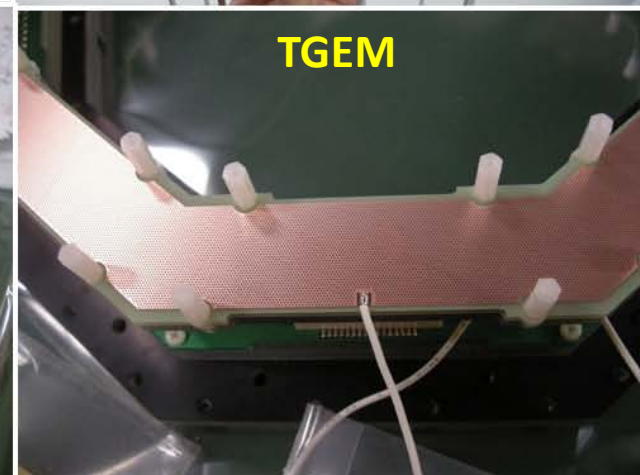
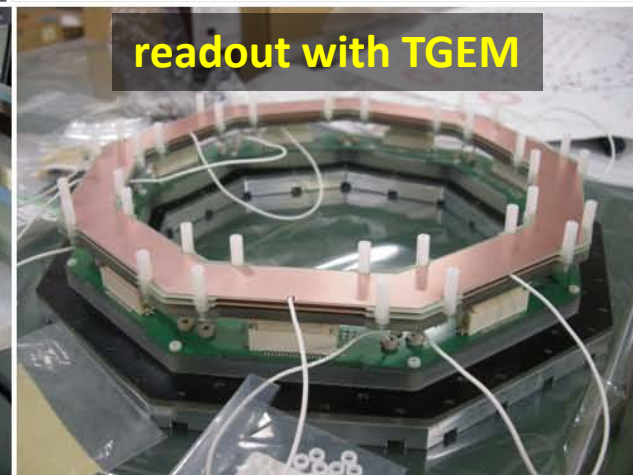
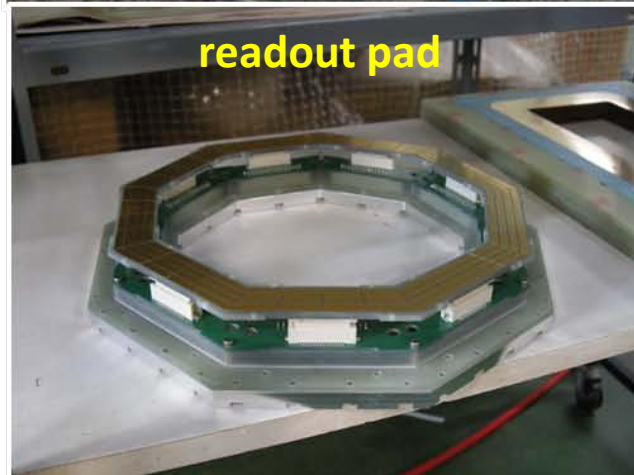
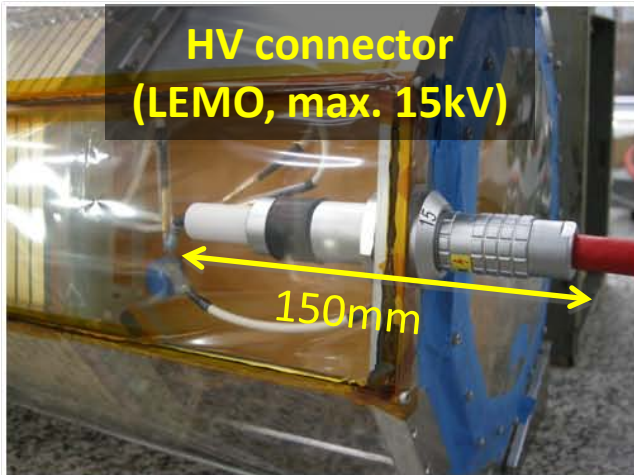
readout with TGM

TGEM

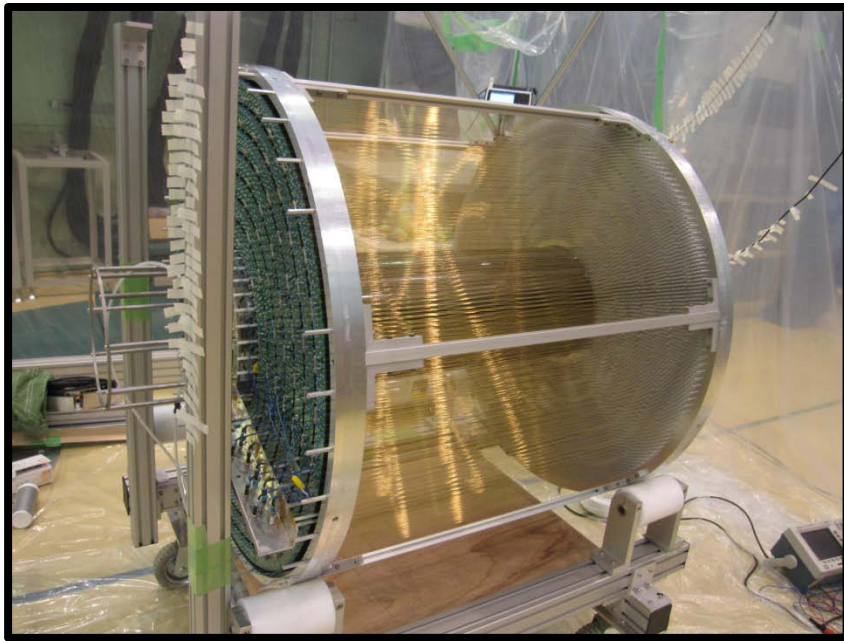
close up view of double-TGEM

installation

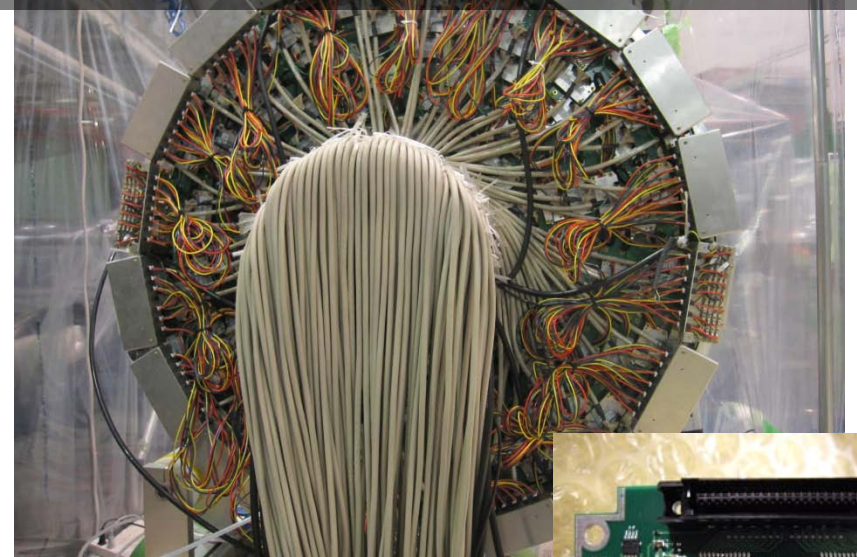
to reduce detector
capacitance,
one side of TGEM
is
divided into 3 parts



Readout Electronics is the same as that of CDC

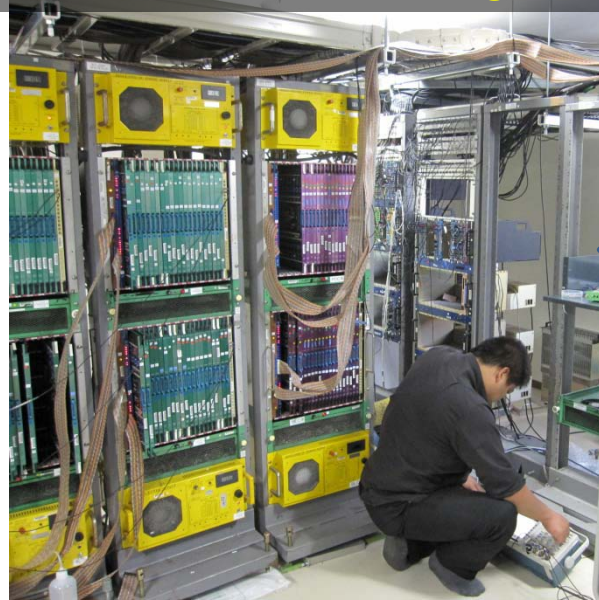


preamp cards and cables are attached

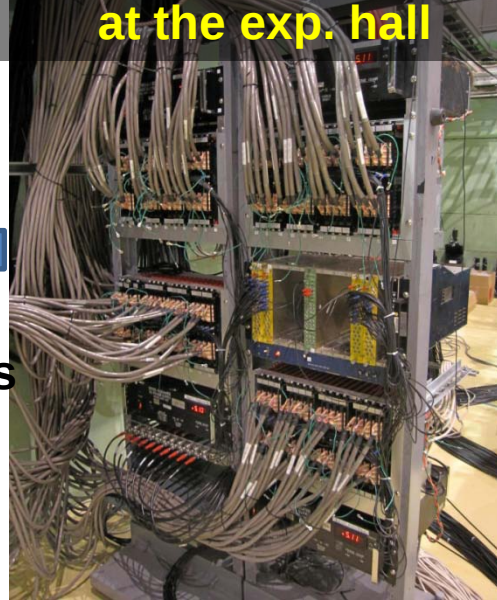


TDC's in the counting room

LVDS→ECL converters
at the exp. hall



ECL
60m
cables



LVDS
8m
cables

- Chip : CXA3183Q
(SONY, low noise ASD IC,
 ~~$\tau=16\text{nsec}$~~ $\tau=80\text{nsec}$)
- Output : LVDS differential
- Gain : 0.8V/pC at preamp
- 4x4=16ch

We measure only time
info. with the TPC!

gas

limit of HV module : 15kV
GEM HV : 4kV
drift length : 30cm



maximum drift-field voltage :
~350V/cm

We choose P10 (Ar/CH₄=90/10) for the TGEM-TPC gas

expected resolution

$$\sigma_x^2 = \sigma_0^2 + \frac{C_d^2 \cdot z}{N_{\text{eff}}}$$

σ_x : total resolution

σ_0 : resolution w/o diffusion

C_d : diffusion constant

z : drift distance

N_{eff} : effective number of electrons

*ϕ -direction resolution is limited
by pad size, e.g.,*

20.0/sqrt(12) = 5.8mm

So we use only z-direction info.

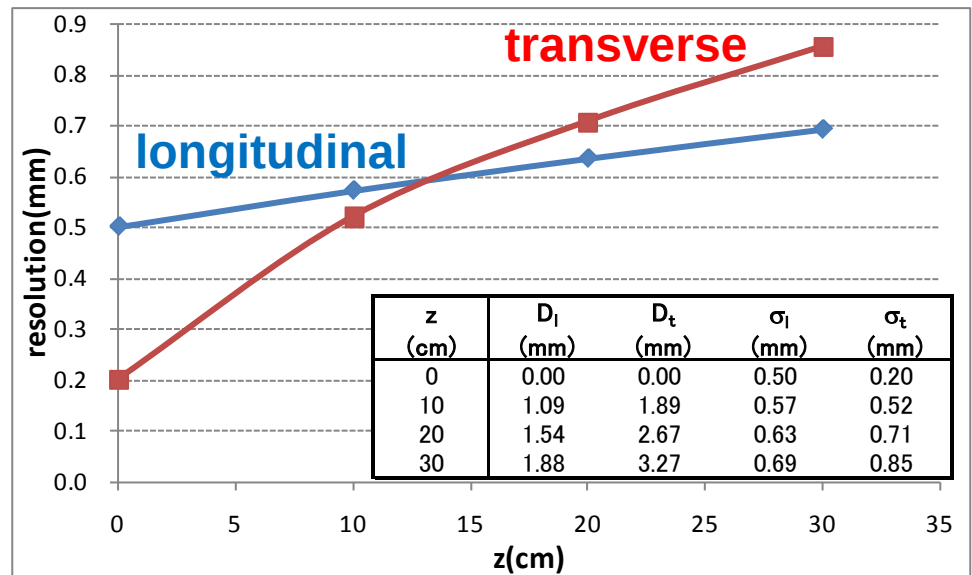
● $E = 150\text{V/cm}$

→ $C_{dl} = 0.34\text{mm}$, $C_{dt} = 0.60\text{mm}$

● $\sigma_{0l} = 0.5\text{mm}$

● $\sigma_{0t} = 0.2\text{mm}$

● $N_{\text{eff}} = 38.7 \cdot 0.4(\text{cm}) = 15.5$



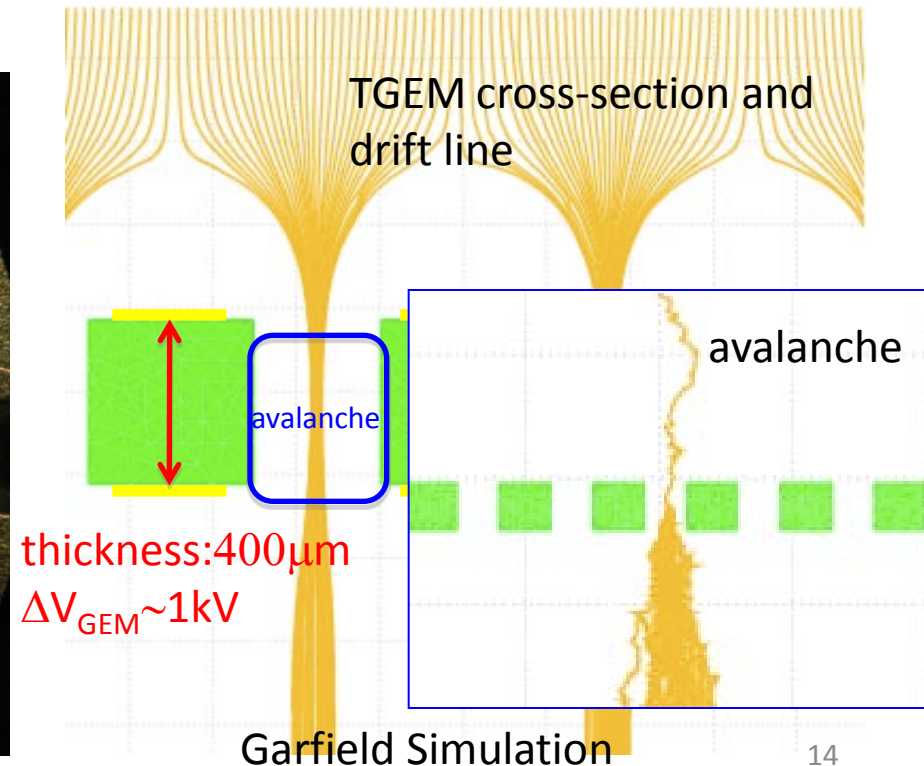
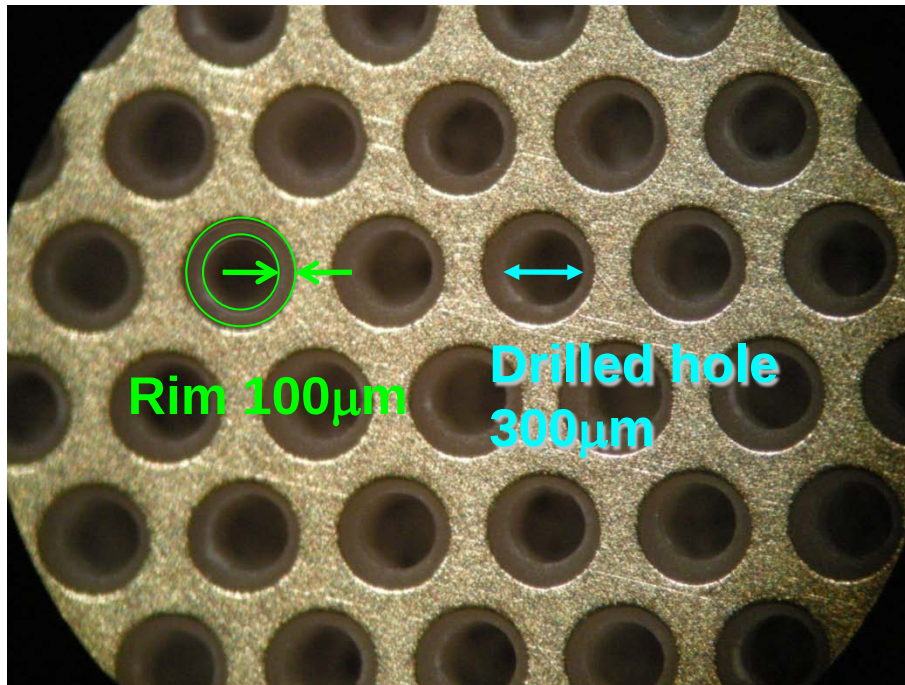
Thick GEM (TGEM)

goal: gain $\sim 10^4$ with stable operation

What is TGEM ?

Thick-GEM is ...

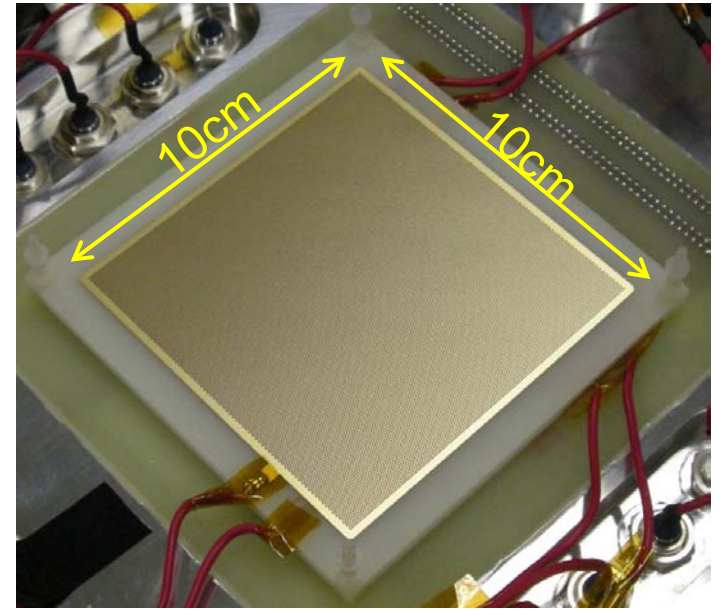
- **cost-effectively fabricated from double-clad G10 plates, using standard printed circuit board (PCB) techniques**
- holes are mechanically drilled (and, if necessary, the hole's rim is chemically etched to prevent discharges)
- a robust, simple to manufacture, high-gain gaseous electron multiplier
- easy to operate and feasible to cover large areas, compared to the standard foil GEM



TGEM prototypes

goal

- gain $\sim 10^4$ @ P10, NTP (double TGEMs)
- stable operation for a month, with gain fluctuation within $\sim$ a few ten % for a month & a few % for a day



many groups have reported TGEMs work successfully, but actually **it's NOT so easy to operate TGEM with high gain stably!**

- they use small TGEMs, e.g. $\sim 3 \times 3 \text{ cm}^2$
- most of them don't discuss stability of TGEM

We have studied basic TGEM behavior and performance.

TGEM prototypes @ RIKEN

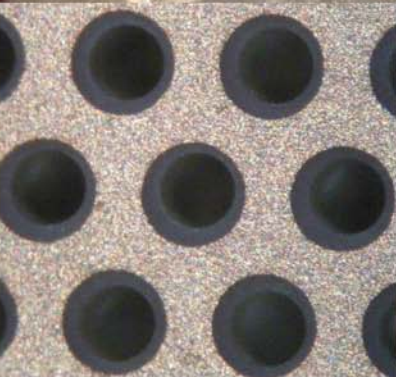
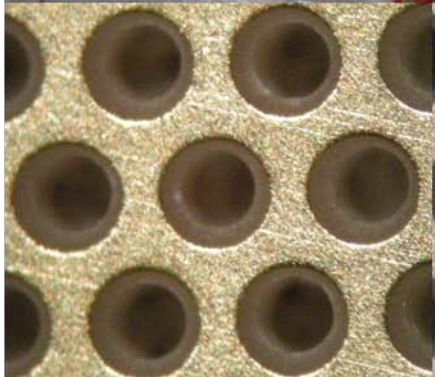
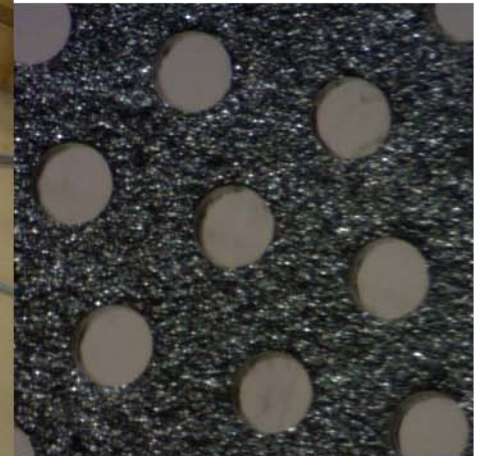
produced by REPIC corp. and TOUKAI DENSHI KOUGYOU corp.

No.	Electrode	Insulator	Thickness[μm]	Hole-diameter[μm]	Rim[μm]	
1	Cu	FR4/UV	200	300	50	$\times 2$
2	Cu	FR4/UV	200	500	—	$\times 2$
3	Cu	FR4/UV	400	300	—	$\times 5$
4	Cu	FR4/UV	400	300	30	$\times 2$
5	Cu	FR4/UV	400	300	50	$\times 2$
6	Cu	FR4	400	300	100	$\times 2$
7	Cu	FR4/UV	400	500	—	$\times 2$
8	C	FR4	400	300	—	$\times 4$
9	C	FR4/UV	400	300	—	$\times 7$
10	C	G10	400	300	—	$\times 2$
11	C	CEM3	400	300	—	$\times 2$
12	C	FR4	600	300	—	$\times 2$
13	C/Cu	FR4/UV	400	300	—	$\times 4$

size : 10cm x 10cm

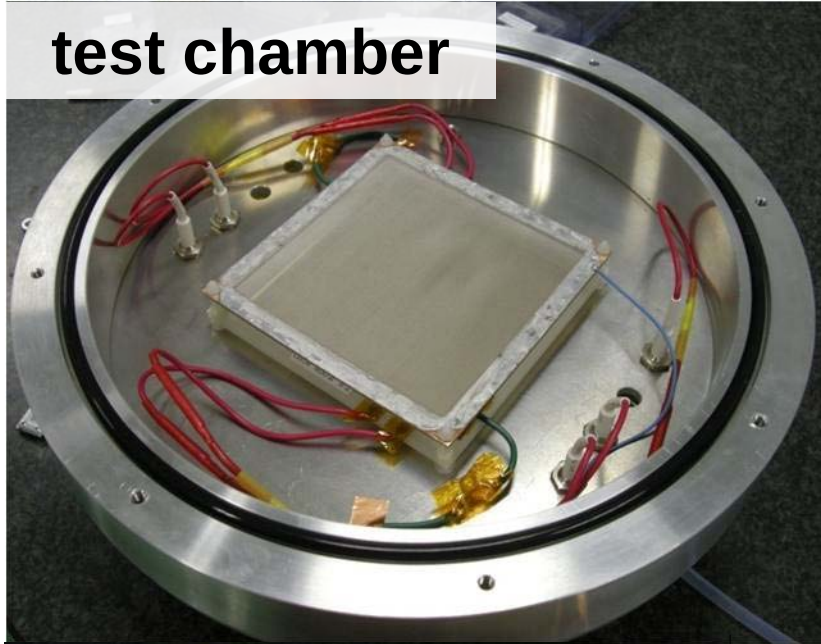
Total 40

many TGEM prototypes

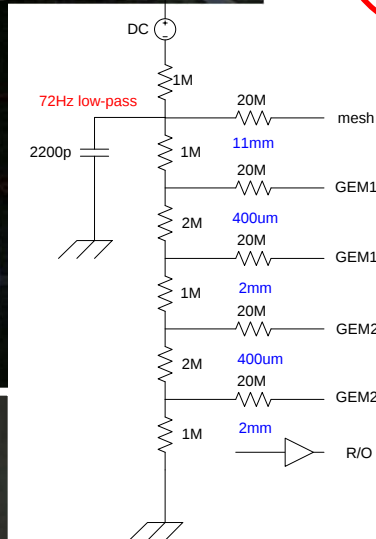
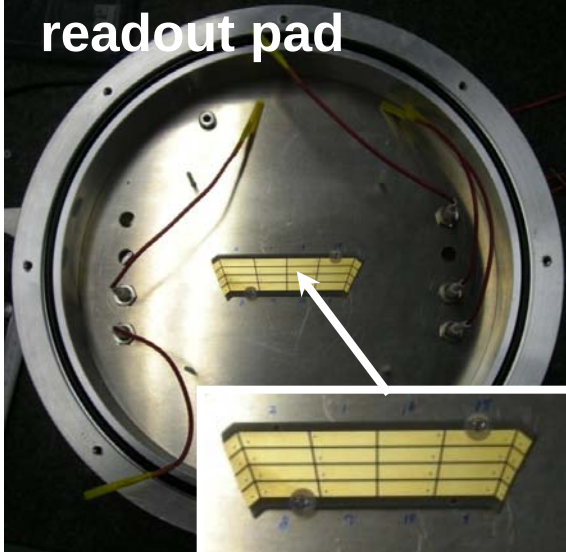


Test bench setup

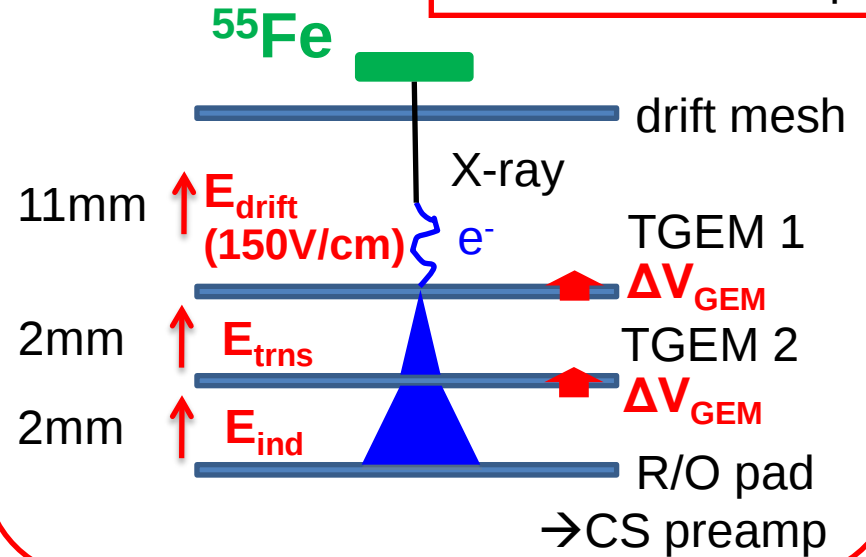
test chamber



readout pad



Double GEM setup



● double TGMs

● Gas : P10 at
1atm, normal temperature

● HV divider with resistive chain
→ Ratio of $\Delta V_{\text{GEM}}/E_{\text{trns}}/E_{\text{ind}}$ is const.

Results of TGEMs

Cu-electrode TGEM

No.	Electrode	Insulator	Thickness[μm]	Hole-diameter[μm]	Rim[μm]	Max gain
1	Cu	FR4/UV	200	300	50	$\sim 10^3$
2	Cu	FR4/UV	200	500	–	–
3	Cu	FR4/UV	400	300	–	$\sim 10^4$
4	Cu	FR4/UV	400	300	30	over 2×10^4
5	Cu	FR4/UV	400	300	50	over 2×10^4
6	Cu	FR4	400	300	100	over 2×10^4
7	Cu	FR4/UV	400	500	–	$\sim 10^3$

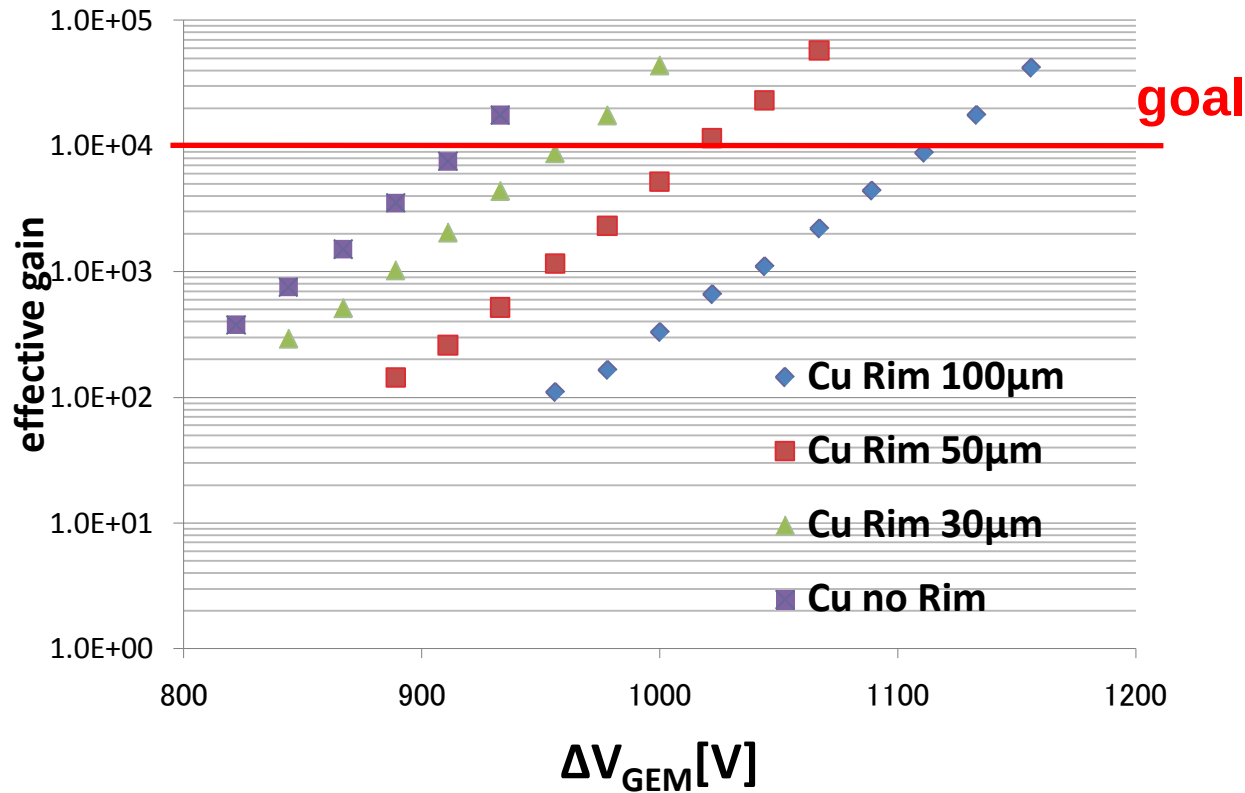
Rim of 50,100 μm : Weizmann method (drilling + masked etching)
 Rim of 30 μm : CERN method (drilling + resist etching)
 w/o Rim (#3) : w/ hydrogen peroxide - sulfuric acid etching

TGEMs with thickness of 400 μm and hole diameter of 300 μm achieve maximum gain of 10^4

dependence on rim size

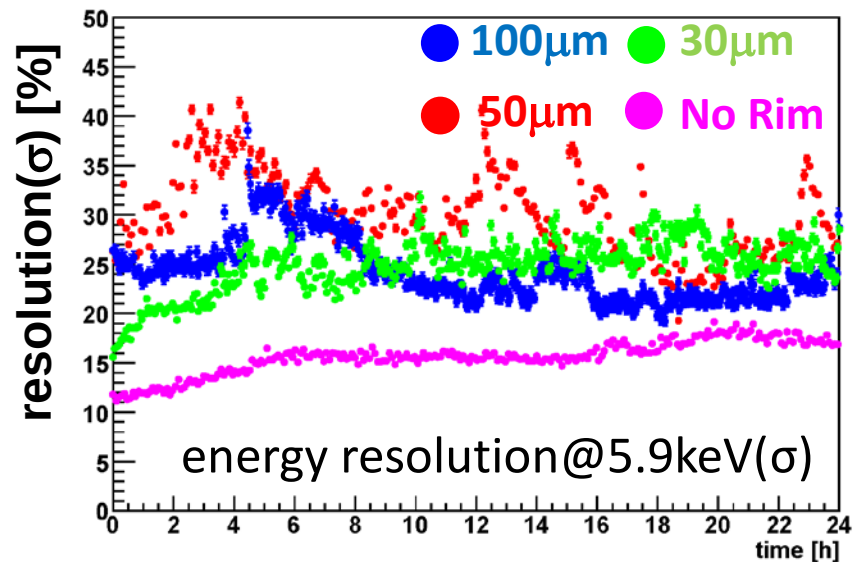
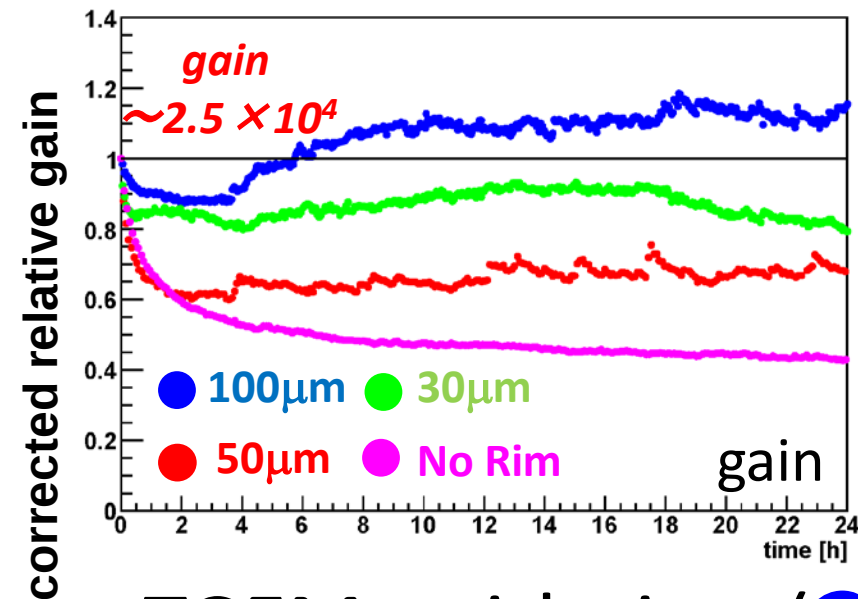
the limits of gain around 10^5 is caused by reather limit (source = ^{55}Fe).

$E_{\text{drift}} = 150\text{V/cm}$		
ΔV_{GEM} (V)	E_{trans} (V/cm)	E_{induct} (V/cm)
1	2.5	7.5



TGEM with larger rims requires higher voltage, but enables higher gain

gain and resolution stability (24h)

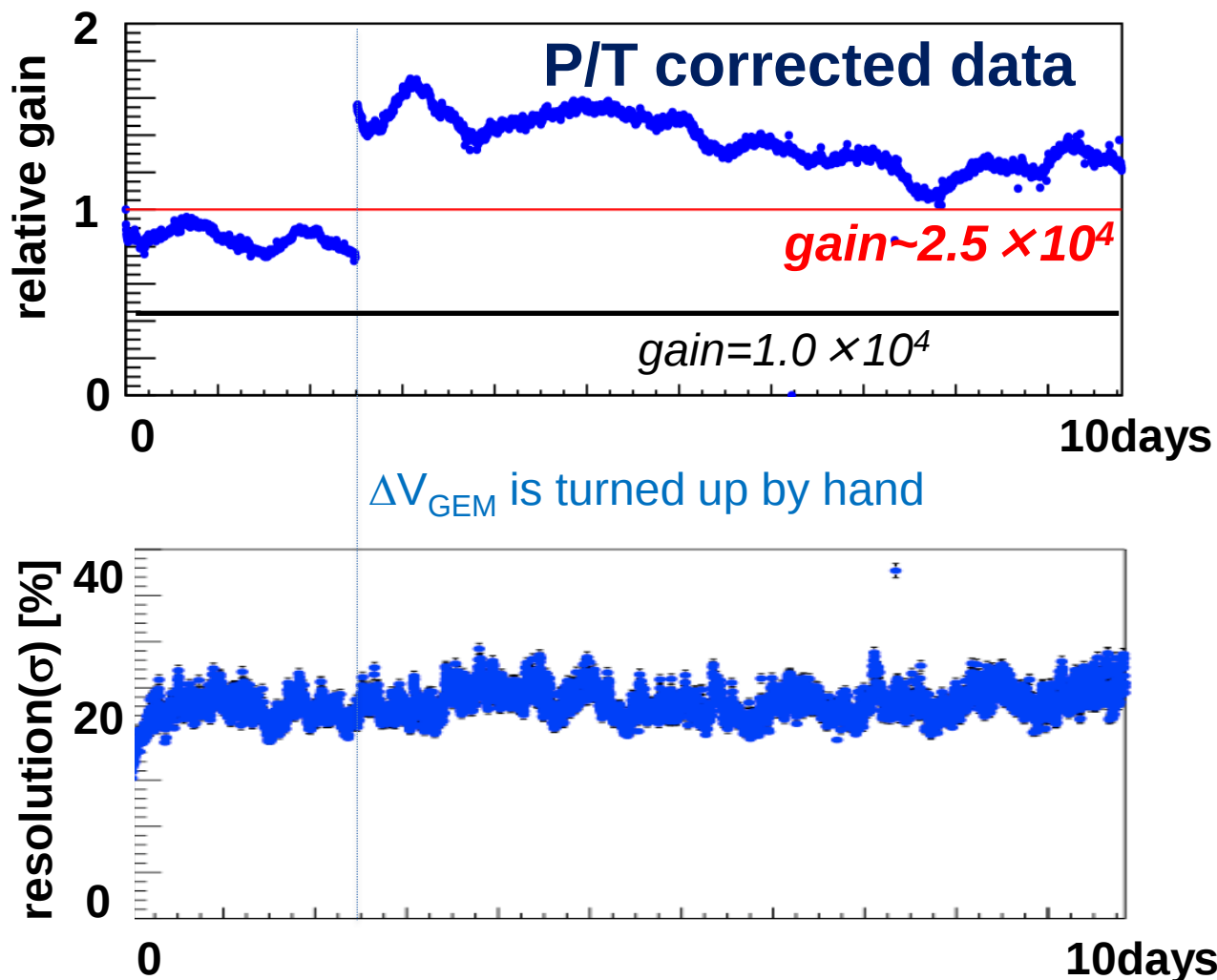


TGEMs with rims (●, ●, ●) are **NOT so stable**
TGEM without rims (●) is **stable**

- initial drop of gain is caused by charge-up (polarization?) of the insulator?
- instability of TGEMs with rims is caused by charge-up of the insulator not metalized.
- mismatch of the center of the etched and drilled holes and incomplete round-shape of rims cause the instability.



long term stability (30 μ m rims TGEM, 10days)



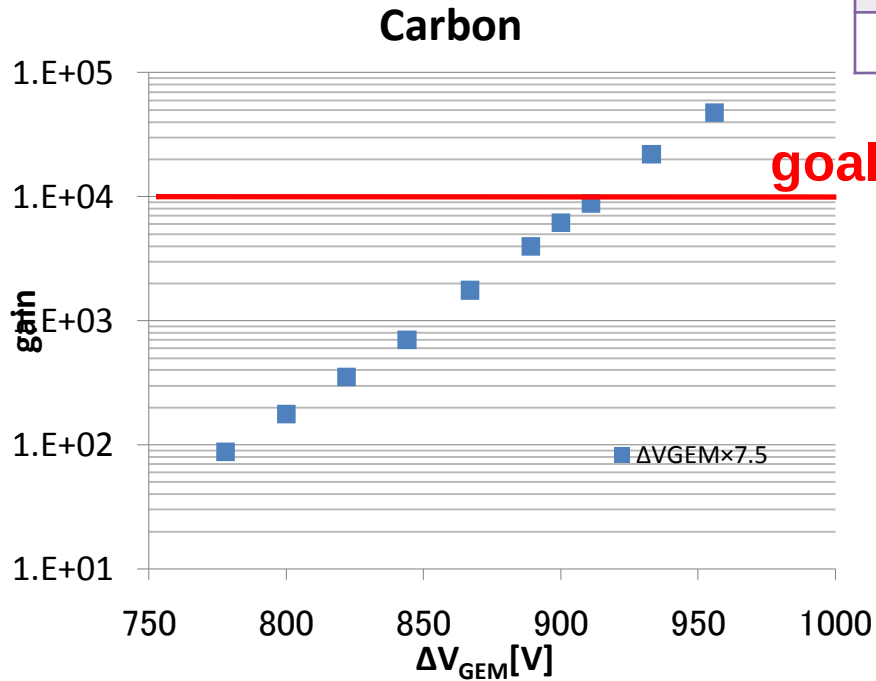
- TGEM with 30 μ m rims can be operated with gain of more than 10^4 for the long term @ P10, NTP
- gain stability is within $\sim 50\%$ /week & $\sim 10\%$ /day

C-electrode TGEM

- To avoid the effects of rims, we are developing a new resistive-electrode TGEM (RETGEM) which has electrodes coated with **graphite paint**.
- RETGEMs have an advantage of being fully spark-protected.

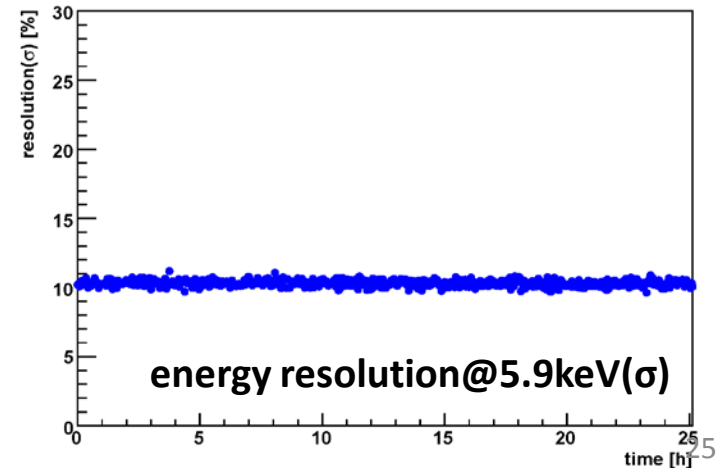
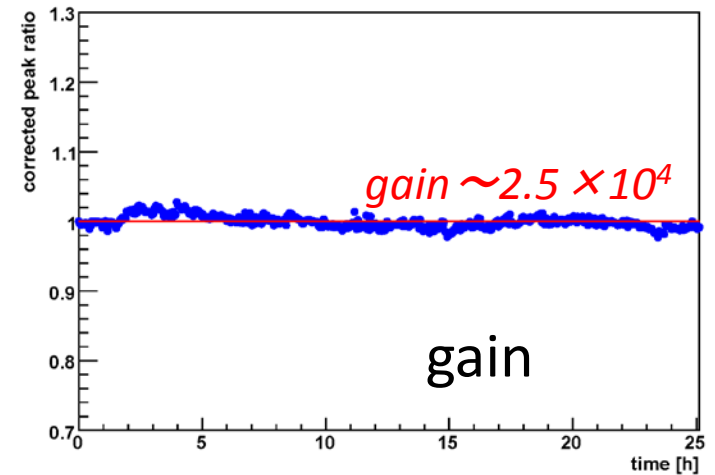
No.	Electrode	Insulator	Thickness[μm]	Hole-diameter[μm]	Rim[μm]	Max gain
8	C	FR4	400	300	–	over 2×10^4
9	C	FR4/UV	400	300	–	–
10	C	G10	400	300	–	$\sim 10^3$
11	C	CEM3	400	300	–	over 2×10^4
12	C	FR4	600	300	–	$\sim 10^2$

Results of the first sample



It seemed that C-electrode TGEMs
work excellent!!!
However...

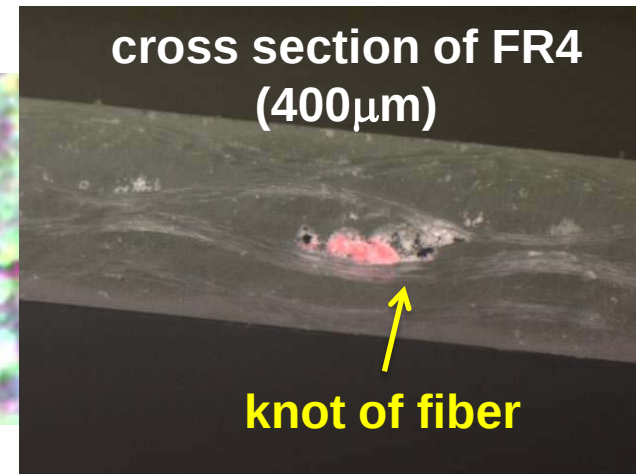
$E_{\text{drift}} = 150 \text{ V/cm}$		
$\Delta V_{\text{GEM}} (\text{V})$	$E_{\text{trans}} (\text{V/cm})$	$E_{\text{induct}} (\text{V/cm})$
1	2.5	7.5



carbon TGEMs have no reproducibility at all !!!

only first 2 out of 11 samples of RETGEMs work !!!

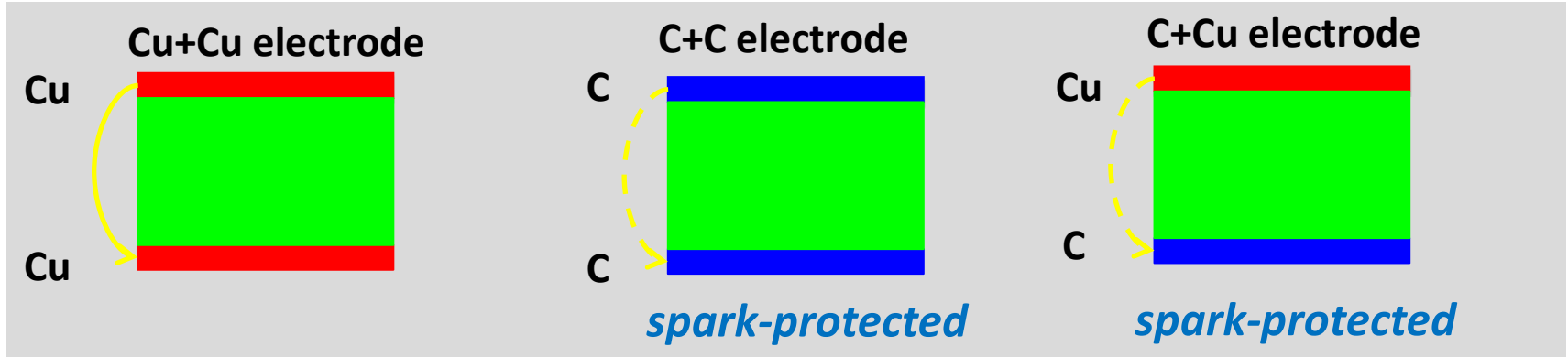
- discharge from burrs arising from drilling process
(but these can be removed using antistatic-brush)
- carbon attachment inside the holes caused by knot of FR4 fiber



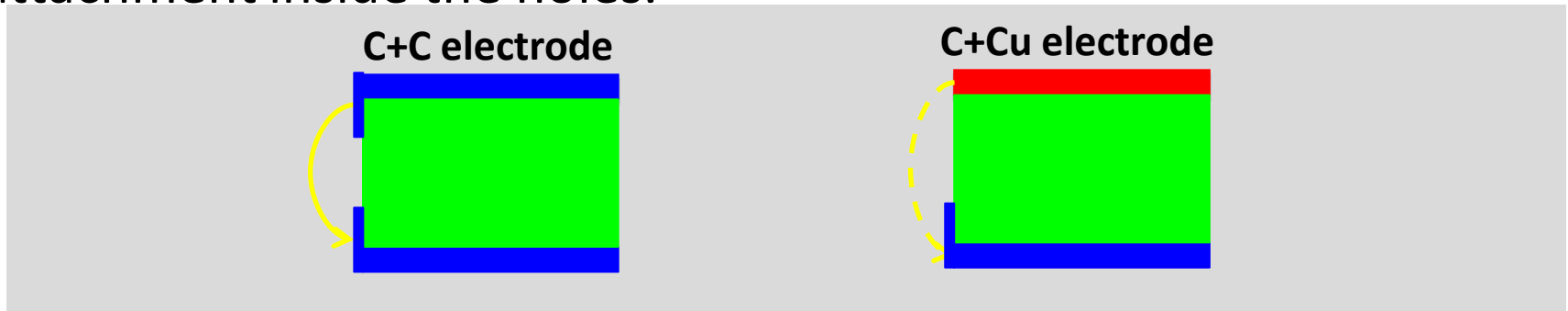
→ now, we have been studying another insulator of
CEM3 not FR4/G10

C/Cu-electrode Hybrid-TGEM

- In principle, if one side of electrode is resistive then that would be spark-protected.



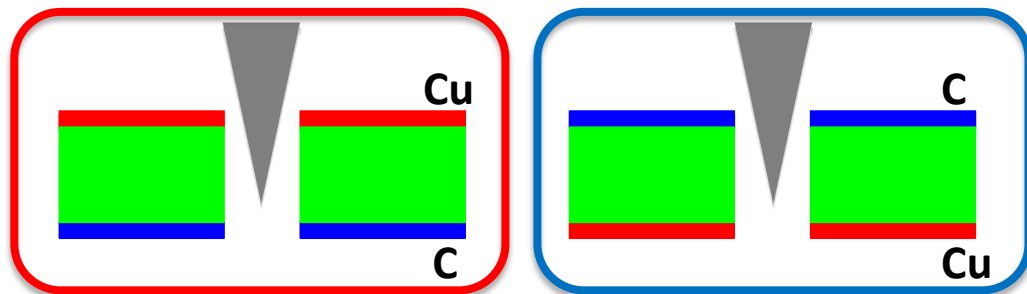
- Hybrid-TGEM would have a possibility of reduction of carbon attachment inside the holes.



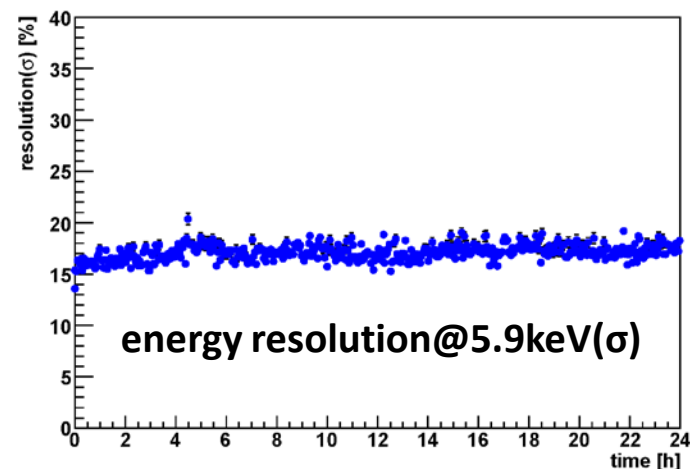
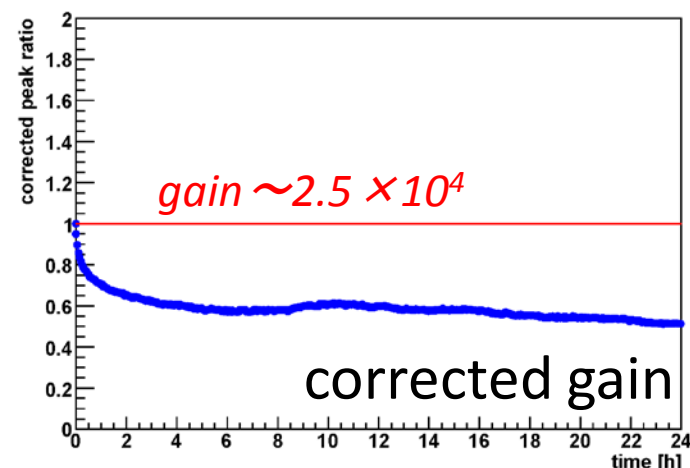
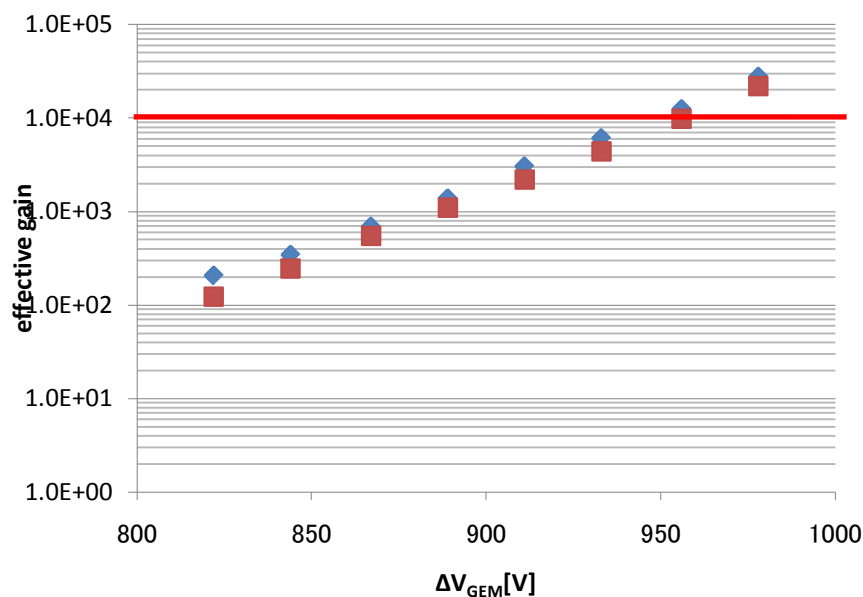
No.	Electrode	Insulator	Thickness[μm]	Hole-diameter[μm]	drill	
13	C/Cu	FR4/UV	400	300	Cu $\rightarrow$ C	$\times 2$
	C/Cu	FR4/UV	400	300	C $\rightarrow$ Cu	$\times 2$

Results of C/Cu-electrode Hybrid TGEM

We tried 2 drilling directions,
i.e. $\text{Cu} \rightarrow \text{C}$ and $\text{C} \rightarrow \text{Cu}$

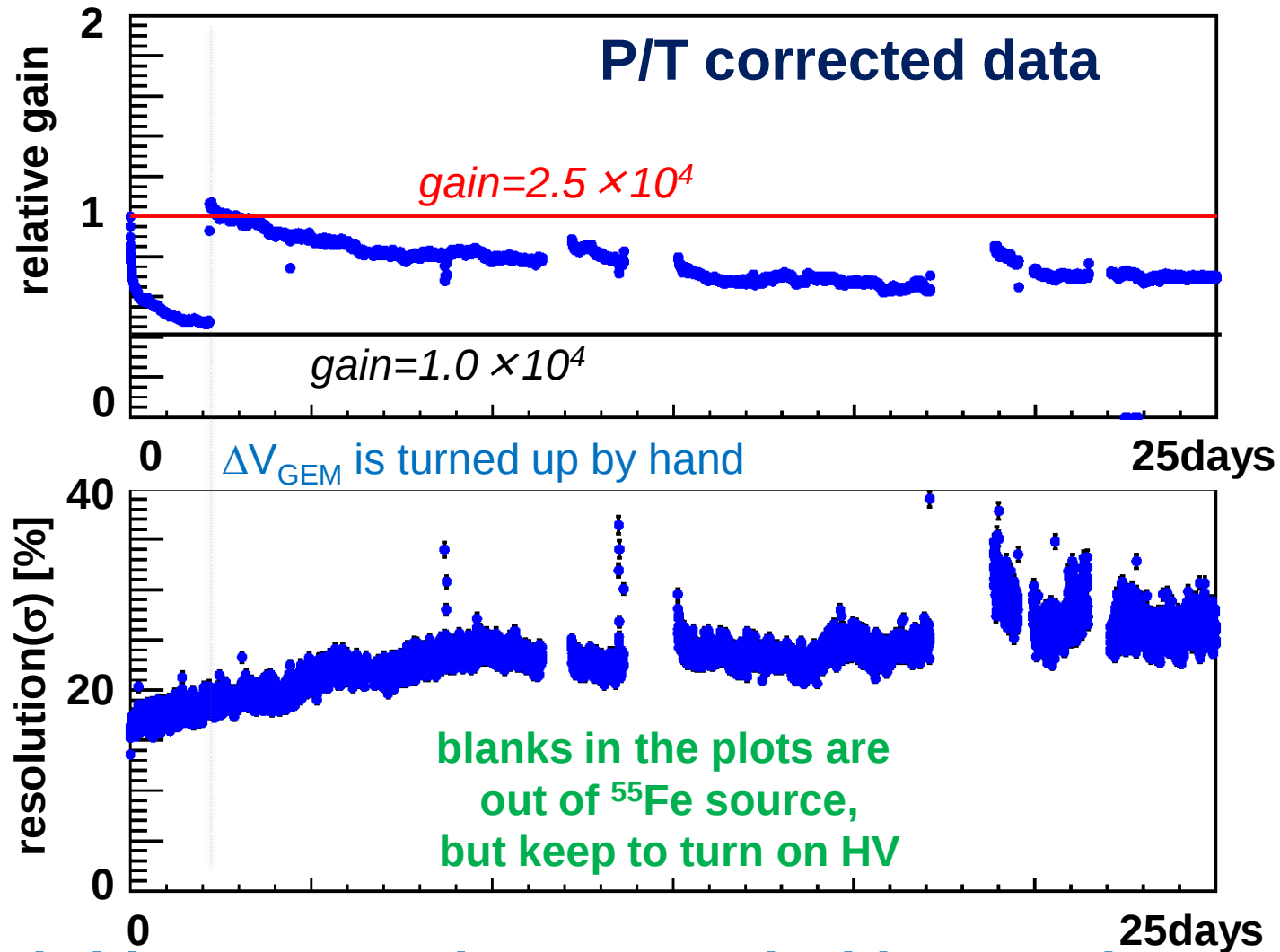


$E_{\text{drift}} = 150 \text{ V/cm}$		
$\Delta V_{\text{GEM}} \text{ (V)}$	$E_{\text{trans}} \text{ (V/cm)}$	$E_{\text{induct}} \text{ (V/cm)}$
1	2.5	7.5



The 2 fabrication methods work similarly

long term stability (hybrid TGEM, 25days)



- hybrid TGEM can be operated with more than gain of 10^4 for the long term @ P10, NTP
- gain stability is within $\sim 20\%$ /week & $\sim 5\%$ /day

Summary

- We have been developing a **TGEM-TPC** for the J-PARC E15 upgrade
- **TGEM-TPC was completed, and commissioning will be started soon**
- **Cu electrode TGEM with 30 μ m rims** can be operated with gain of more than 10^4 for the long term rather stably @ P10, NTP
- **C-electrode TGEM** is far from goal...
- **C/Cu electrode TGEM** can be operated with gain of more than 10^4 for the long term stably @ P10, NTP

C electrode TGEM with CEM3 insulator

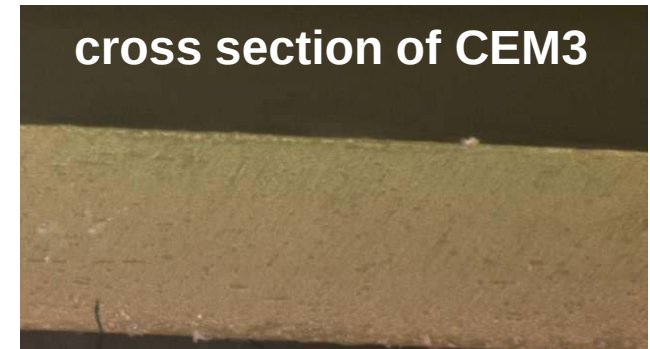
A cross section of CEM3 is very clean compared with that of FR4.



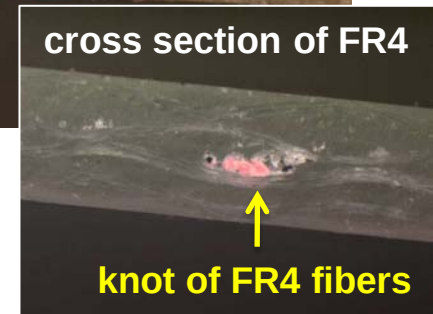
reduction of carbon attachment inside the holes

● Now we are investigating reproducibility of CEM3 RETGEM

● A disadvantage of CEM3 RETGEM is its flexibility

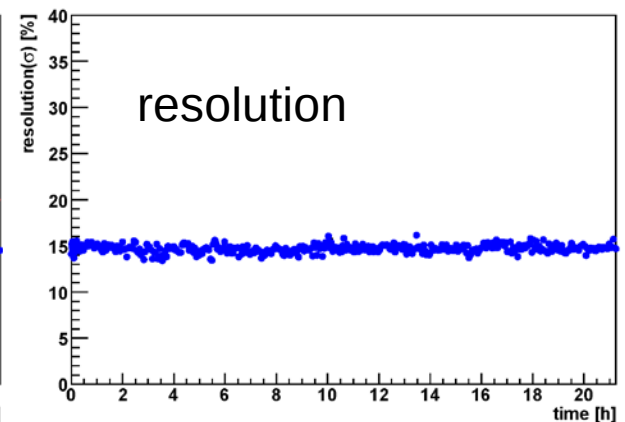
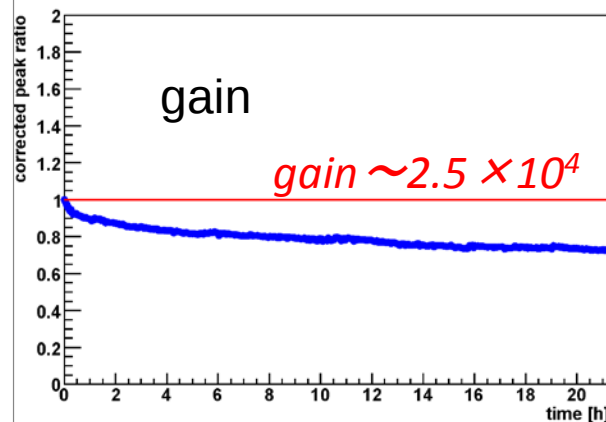
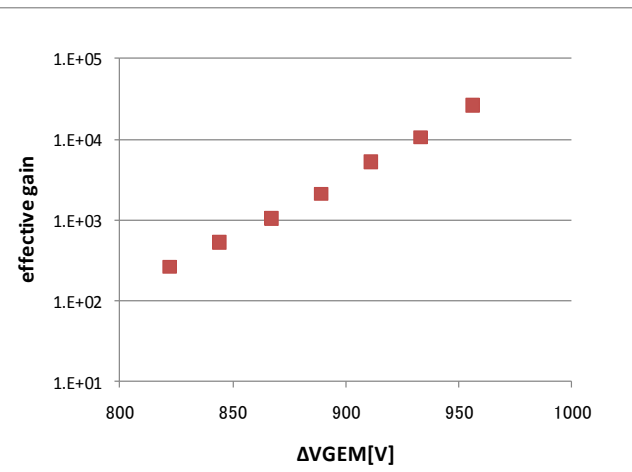


cross section of CEM3



cross section of FR4

knot of FR4 fibers



How to make Rims

There are 2 ways

Weizmann method

drilling + masked etching

Advantage:

large rims can be made easily

Disadvantage:

difficult to center etched and drilled holes

CERN method

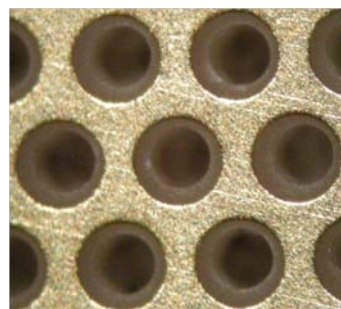
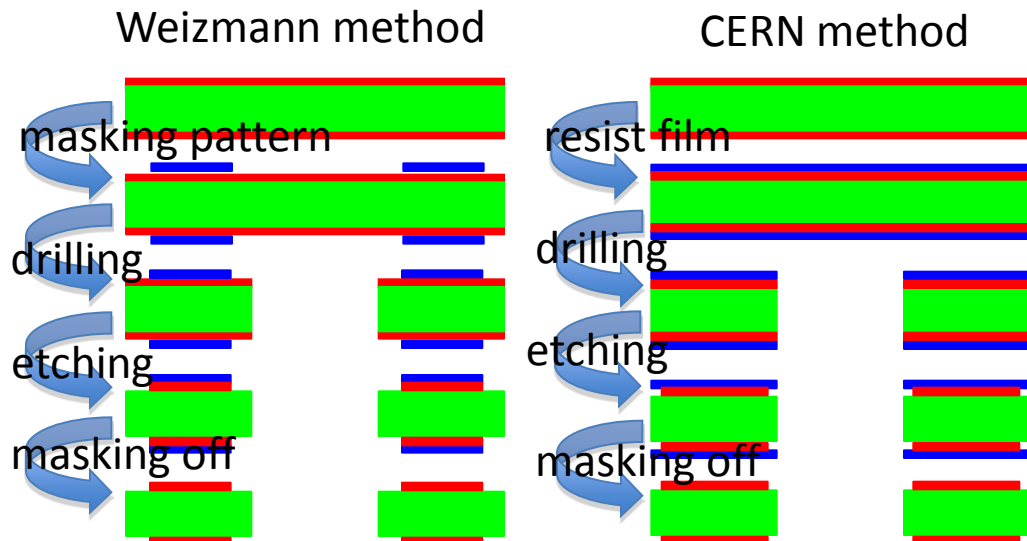
drilling + resist etching

Advantage:

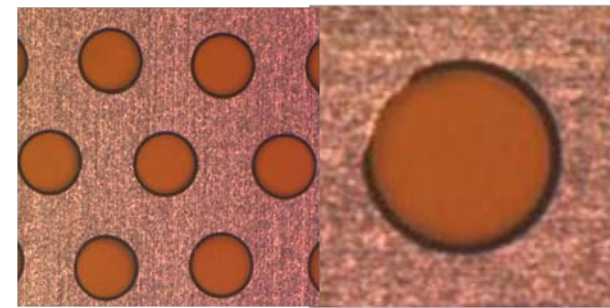
center of etched and drilled holes are the same

Disadvantage:

difficult to make large rims



Weizmann

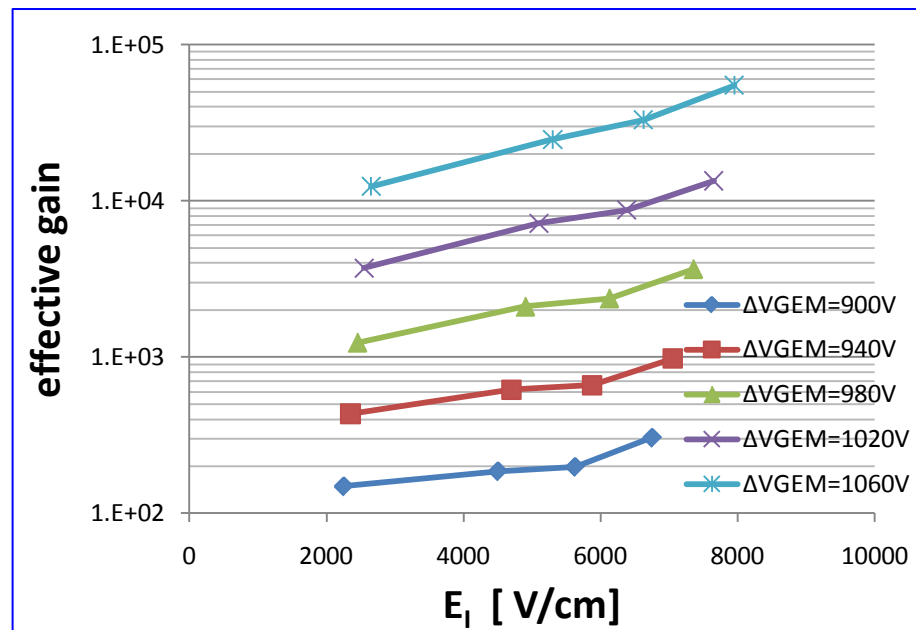
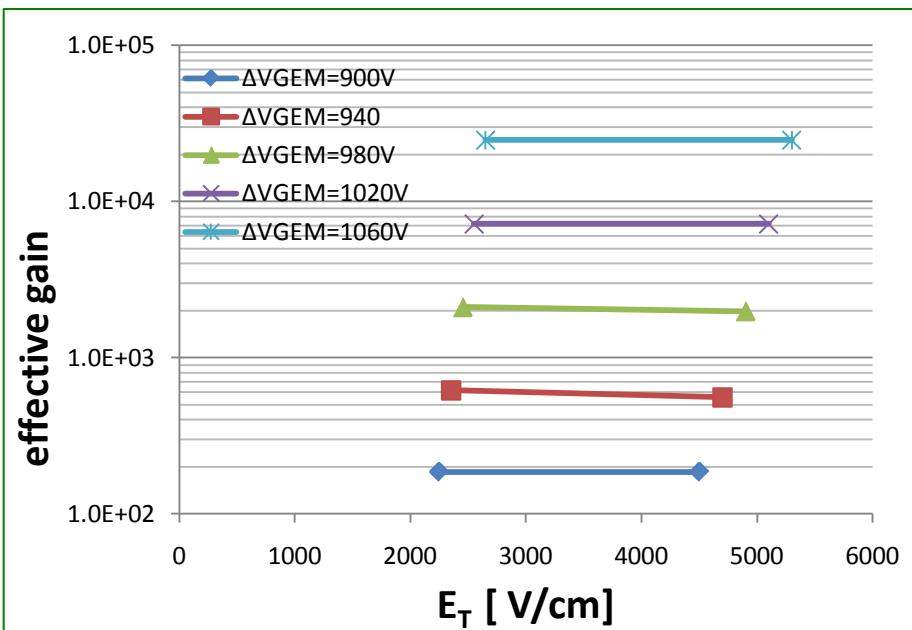
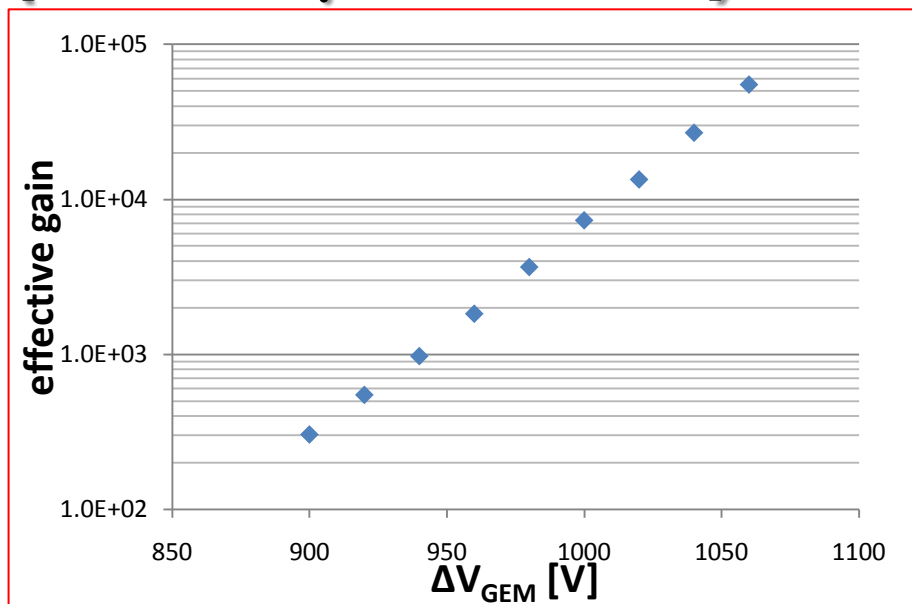
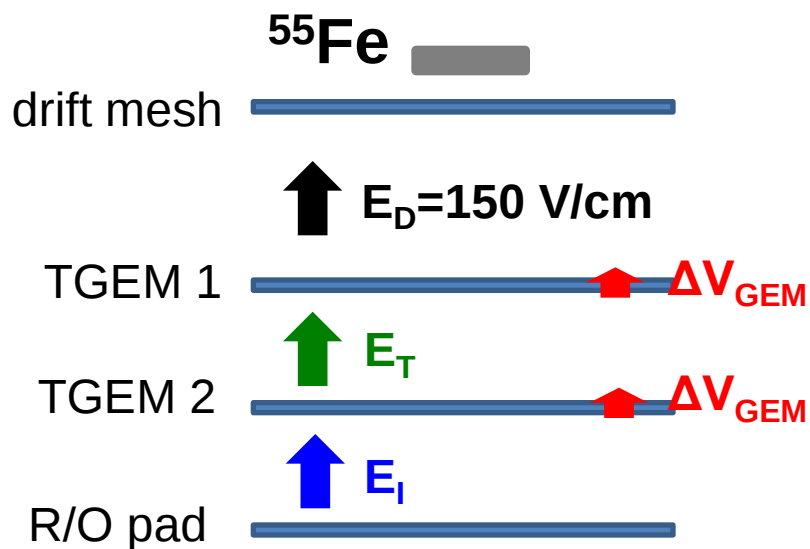


CERN

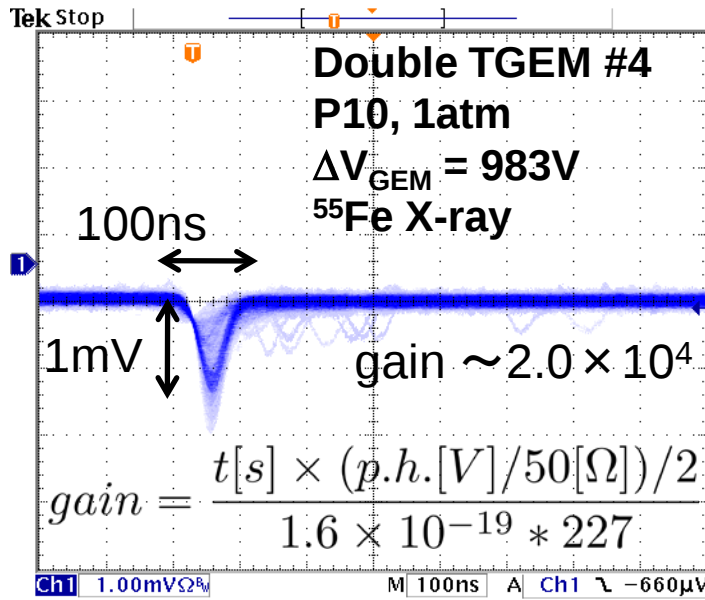
(failure)

It's known that large rims cause instability of TGEMs, although those enable TGEMs to reach high gain.

ET, EI dependence (Rim 30 μ m TGEM)

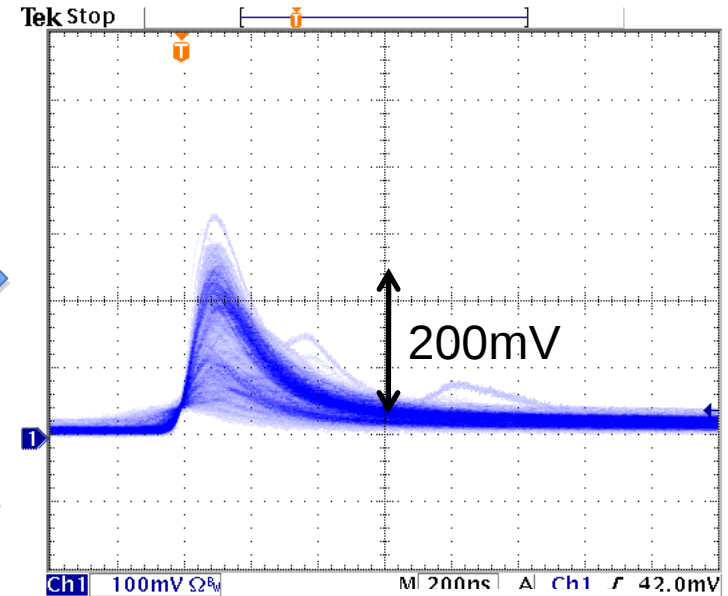


signals and goal of the studies



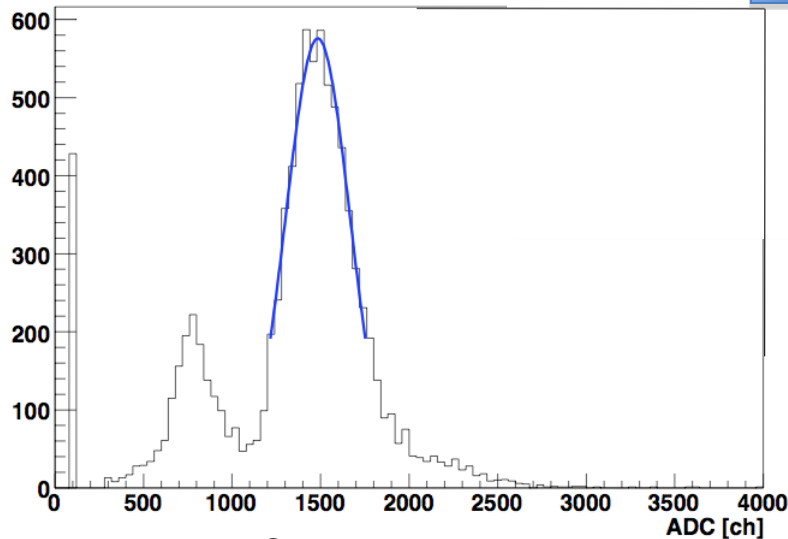
raw signal

preamp



preamp out

ADC

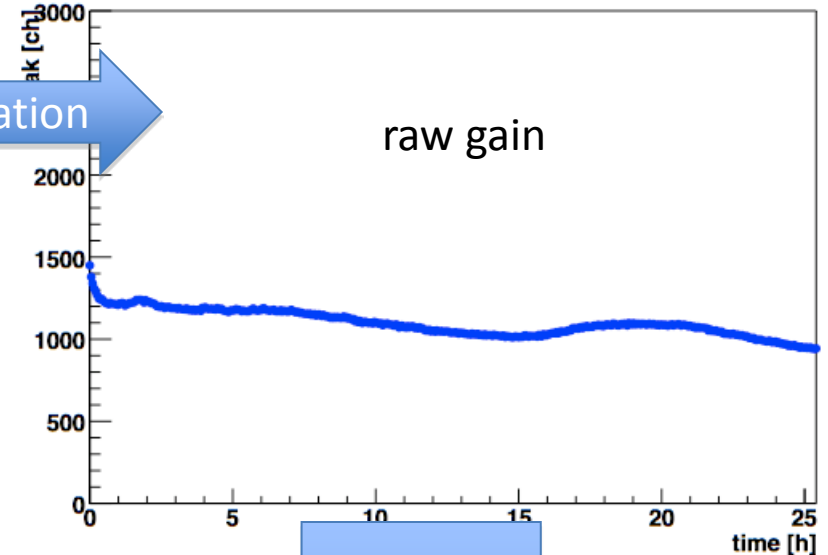
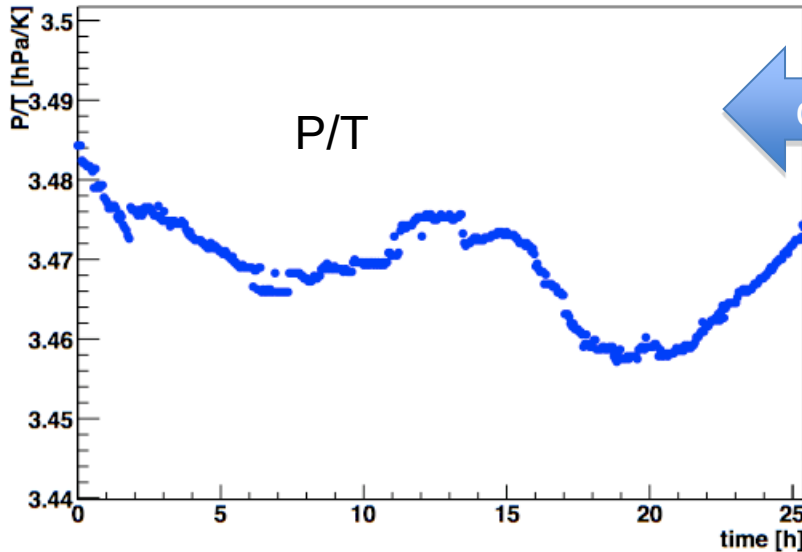


goal for of TGEM study

in consideration of TPC
operation,

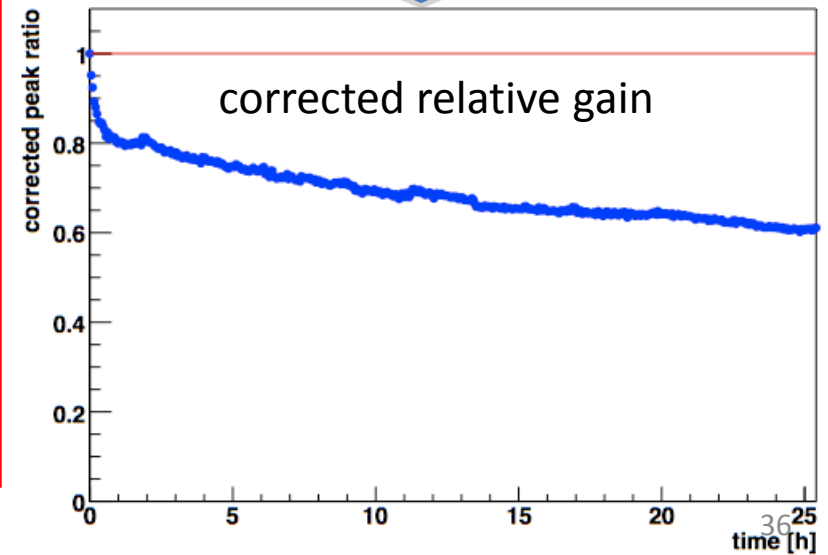
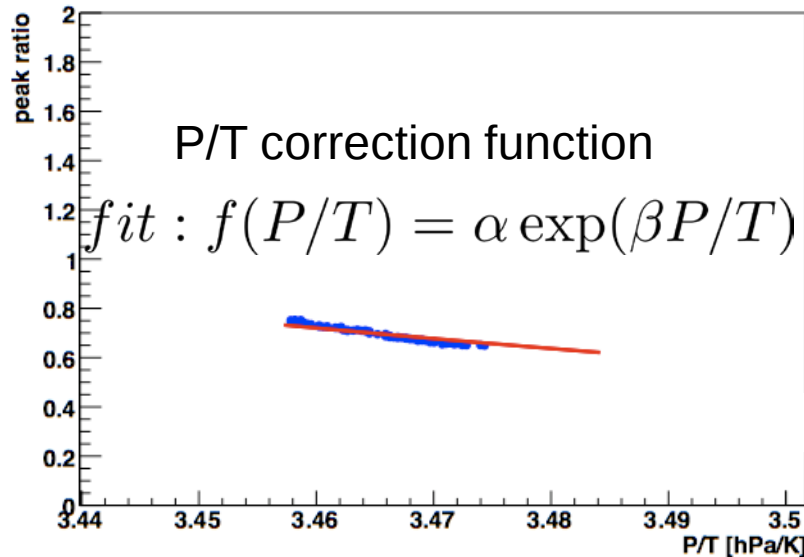
- effective gain $\sim 10^4$
- long time stability of gain and resolution

P/T correction of gain



correlation

correction



after-treatment of C-electrode TGEM

We tried many items to make the C-electrode TGEMs work

- ethanol cleaning → ×
 - does not improve at all
- plasma etching → △
 - improves a little bit, but it's not perfect
 - does not remove burrs of carbon
- removing burrs with resist-film and/or antistatic-brush → △
 - removes burrs, but does not improve
- steam cleaning → ×
 - does not improve at all
- polyimide etching → ?
 - effects are depend on material of the insulator
 - and also depend on etching time
- change insulator (FR4/UV → CEM3) → ?
 - CEM3 TGEMs work good, but that are after polyimide etching
(we did not check the without the etching)

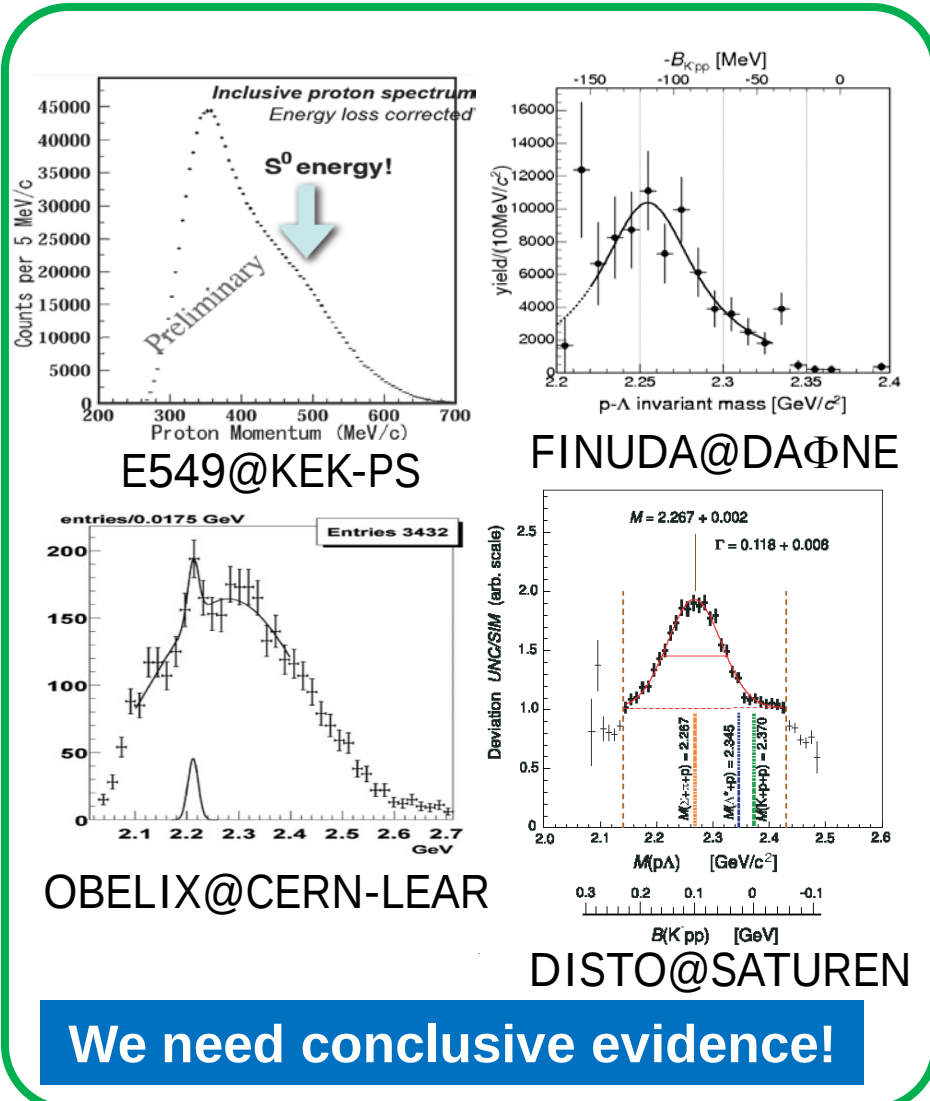
We have to study more

Outlook

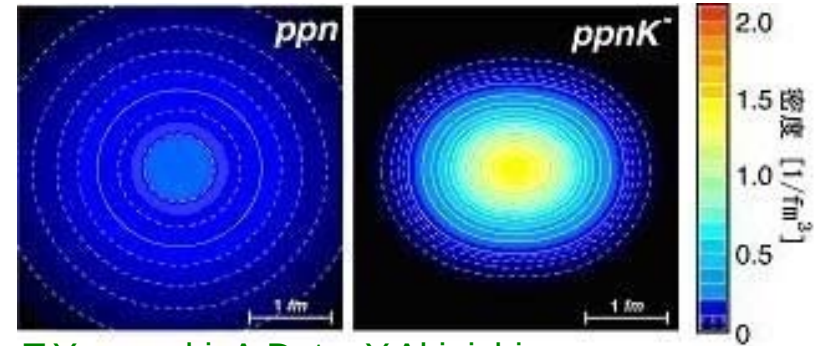
- Nonagonal TGEMs (w/o rims and Cu-rim-30 μ m) and Hybrid-TGEMs for the TPC were produced, and studies have started now.
- Development of Carbon TGEMs will be continued in the year 2010.

Physics Motivation

deeply-bound kaonic nuclear states exist?



We need conclusive evidence!



T.Yamazaki, A.Dote, Y.Akaiishi
PLB587,167(2004).

